

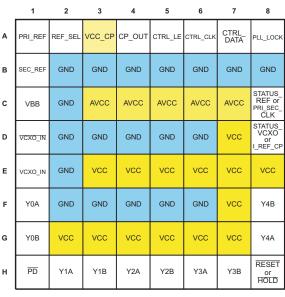
3.3-V HIGH PERFORMANCE CLOCK SYNCHRONIZER AND JITTER CLEANER

Check for Samples: CDCM7005

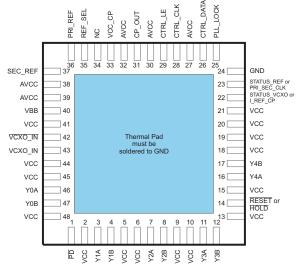
FEATURES

- High Performance LVPECL and LVCMOS PLL Clock Synchronizer
- Two Reference Clock Inputs (Primary and Secondary Clock) for Redundancy Support With Manual or Automatic Selection
- Accepts LVCMOS Input Frequencies Up to 200 MHz
- VCXO_IN Clock is Synchronized to One of the Two Reference Clocks
- VCXO_IN Frequencies Up to 2.2 GHz (LVPECL)
- Outputs Can Be a Combination of LVPECL and LVCMOS (Up to Five Differential LVPECL Outputs or Up to 10 LVCMOS Outputs)
- Output Frequency is Selectable by x1, /2, /3, /4, /6, /8, /16 on Each Output Individually
- Efficient Jitter Cleaning From Low PLL Loop Bandwidth
- Low Phase Noise PLL Core
- Programmable Phase Offset (PRI_REF and SEC_REF to Outputs)
- Wide Charge Pump Current Range From 200 µA to 3 mA
- Dedicated Charge Pump Supply (VCC_CP) for Wide Tuning Voltage Range VCOs
- Presets Charge Pump to VCC_CP/2 for Fast Center-Frequency Setting of VC(X)O
- Analog and Digital PLL Lock Indication
- Provides VBB Bias Voltage Output for Single-Ended Input Signals (VCXO_IN)
- Frequency Hold-Over Mode Improves Fail-Safe Operation
- Power-Up Control Forces LVPECL Outputs to 3-State at V_{CC} < 1.5 V
- SPI Controllable Device Setting
- 3.3-V Power Supply
- Packaged in 64-Pin BGA (0,8 mm Pitch ZVA) or 48-Pin QFN (RGZ)
- Industrial Temperature Range –40°C to 85°C

PIN ASSIGNMENTS (TOP VIEW)



P0022-01



P0023-01



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

DESCRIPTION

The CDCM7005 is a high-performance, low phase noise and low skew clock synchronizer that synchronizes a VCXO (voltage controlled crystal oscillator) or VCO (voltage controlled oscillator) frequency to one of the two reference clocks. The programmable pre-divider M and the feedback-dividers N and P give a high flexibility to the frequency ratio of the reference clock to VC(X)O:

- VC(X)O_IN / PRI_REF = (N x P) / M or
- VC(X)O_IN / SEC_REF = (N x P) / M

VC(X)O_IN clock operates up to 2.2 GHz. Through the selection of external VC(X)O and loop filter components, the PLL loop bandwidth and damping factor can be adjust to meet different system requirements.

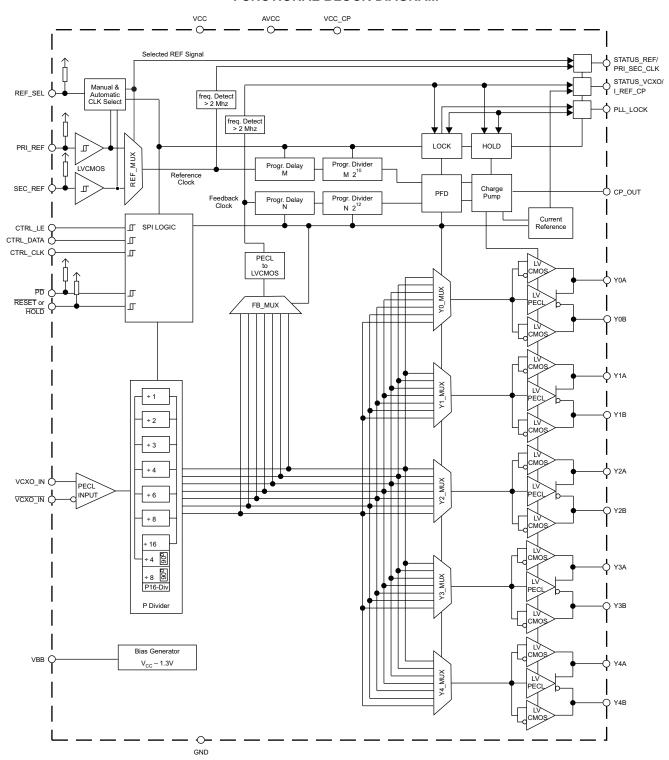
The CDCM7005 can lock to one of two reference clock inputs (PRI_REF and SEC_REF), supports frequency hold-over mode and fast-frequency-locking for fail-safe and increased system redundancy. The outputs of the CDCM7005 are user definable and can be any combination of up to five LVPECL outputs or up to 10 LVCMOS outputs. The LVCMOS outputs are arranged in pairs (Y0A:Y0B, Y1A:Y1B, ...), so that each pair has the same frequency. But each output can be separately inverted and disabled. The built in synchronization latches ensure that all outputs are synchronized for low output skew.

All device settings, like outputs signaling, divider value, input selection, and many more, are programmable by SPI (3-wire serial peripheral interface). SPI allows individually control of the device settings.

The device operates in 3.3-V environment and is characterized for operation from -40°C to 85°C.



FUNCTIONAL BLOCK DIAGRAM



B0057-01



Table 1. PIN ASSINGMENT

| TEI | RMINAL | | 1/0 | DESCRIPTION | | |
|------------------|---|--|-----------------|---|--|--|
| NAME | BGA | QFN | I/O | DESCRIPTION | | |
| vcc | D7, E3, E4, E5, E6, E7, E8, F7, G2, G3, G4, G5, G6, G7 | 2, 5, 6, 9, 10, 13, 15, 18, 19, 20, 21, 41, 44, 45; 48 | Power | 3.3-V supply. V_{CC} and AV_{CC} should always have the same supply voltage. It is recommended that AV_{CC} use its own supply filter. | | |
| GND | B2, B3, B4, B5, B6, B7, B8, C2, D2, D3, D4, D5, D6, E2, F2, F3, F4, F5, | Thermal pad and pin 24 | Ground | Ground | | |
| AVCC | C3, C4, C5, C6, C7 | 27, 30, 32, 38, 39 | Analog Power | 3.3-V analog power supply. There is no internal connection between AV $_{\rm CC}$ and V $_{\rm CC}$. It is recommended that AV $_{\rm CC}$ use its own supply filter. | | |
| VCC_CP | А3 | 33 | Power | This is the charge pump power supply pin used to have the same supply as the external VCO. It can be set from 2.3 V to 3.6 V. | | |
| CTRL_LE | A5 | 29 | I | LVCMOS input, control latch enable for serial programmable Interface (SPI), with hysteresis. Unused or floating inputs must be tied to proper logic level. A $20k\Omega$ or larger pull–up resistor to VCC is recommended. | | |
| CTRL_CLK | A6 | 28 | I | LVCMOS input, serial control clock input for SPI, with hysteresis. Unused or floating inputs must be tied to proper logic level. A $20k\Omega$ or larger pull–up resistor to VCC is recommended. | | |
| CTRL_DATA | A7 | 26 | I | LVCMOS input, serial control data input for SPI, with hysteresis. Unused or floating inputs must be tied to proper logic level. A $20k\Omega$ or larger pull–up resistor to VCC is recommended. | | |
| PD | H1 | 1 | I | LVCMOS input, asynchronous power down (\overline{PD}) signal. This pin is low active and can be activated external or by the corresponding bit in the SPI register (in case of logic high, the SPI setting is valid). Switches the device into power-down mode. Resets M- and N-Divider, 3-states charge pump, STATUS_REF, or PRI_SEC_CLK pin, STATUS_VCXO or I_REF_CP pin, PLL_LOCK pin, VBB pin and all Yx outputs. Sets the SPI register to default value; has internal 150-k Ω pullup resistor. It is recommended to ramp up the \overline{PD} with the same time as V_{CC} and AV_{CC} or later. The ramp up rate of the \overline{PD} should not be faster than the ramp up rate of V_{CC} and AV_{CC} . | | |
| RESET or HOLD | Н8 | 14 | I | This LVCMOS input can be programmed (SPI) to act as HOLD or RESET. RESET is the default function. This pin is low active and can be activated external or via the corresponding bit in the SPI register. In case of RESET, the charge pump (CP) is switched to 3-state and all counters (N, M, P) are reset to zero (the initial divider settings are maintained in SPI registers). The LVPECL outputs are static low and high respectively and the LVCMOS outputs are all low or high if inverted. RESET is not edge triggered and should have a pulse duration of at least 5 ns. In case of HOLD, the CP is switched in to 3-state mode only. After HOLD is released and with the next valid reference clock cycle the charge pump is switched back in to normal operation (CP stays in 3-state as long as no reference clock is valid). During HOLD, the P divider and all outputs Yx are at normal | | |
| | | | | operation. This mode allows an external control of the frequency hold-over mode. The input has an internal 150-k Ω pullup resistor. | | |
| VCXO_IN | E1 | 43 | 1 | VCXO LVPECL input | | |
| VCXO_IN | D1 | 42 | ı | Complementary VCXO LVPECL input | | |
| PRI_REF | A1 | 36 | 1 | LVCMOS input for the primary reference clock, with an internal 150-k Ω pullup resistor and input hysteresis. | | |
| SEC_REF | B1 | 37 | I | LVCMOS input for the secondary reference clock, with an internal 150-kΩ pullup resistor and input hysteresis. | | |

Submit Documentation Feedback

Copyright © 2005–2013, Texas Instruments Incorporated



Table 1. PIN ASSINGMENT (continued)

| TER | RMINAL | | | DECORPTION |
|---|--|---|------|--|
| NAME | BGA | QFN | I/O | DESCRIPTION |
| REF_SEL | A2 | 35 | I | LVCMOS reference clock selection input. In the manual mode the REF_SEL signal selects one of the two input clocks: REF_SEL [1]: PRI_REF is selected; REF_SEL [0]: SEC_REF is selected; The input has an internal 150-kΩ pullup resistor. |
| CP_OUT | A4 | 31 | 0 | Charge pump output |
| VBB | C1 | 40 | 0 | Bias voltage output to be used to bias unused complementary input $\overline{VCXO_IN}$ for single ended signals. The output of VBB is $V_{CC}-1.3$ V. The output current is limited to about 1.5 mA. |
| | | | | This output can be programmed (SPI) to provide either the STATUS_REF or PRI_SEC_CLK information. This pin is set high if one of the STATUS conditions is valid. STATUS_REF is the default setting. |
| STATUS_REF or PRI_SEC_CLK | C8 | 23 | 0 | In case of STATUS_REF, the LVCMOS output provides the Status of the Reference Clock. If a reference clock with a frequency above 2 MHz is provided to PRI_REF or SEC_REF STATUS_REF will be set high. |
| | | | | In case of PRI_SEC_CLK, the LVCMOS output indicates whether the primary clock [high] or the secondary clock [low] is selected. |
| | D8 | | | This LVCMOS output can be programmed (SPI) to provide either the STATUS_VCXO information or serve as current path for the charge pump (CP). STATUS_VCXO is the default setting. |
| STATUS_VCXO or I_REF_CP | | 22 | 22 O | In case of STATUS_VCXO, the LVCMOS output provides the status of the VCXO input (frequencies above 2 MHz are interpreted as valid clock; active high). |
| o | | | | In case of I_REF_CP, it provides the current path for the external reference resistor (12 k Ω ±1%) to support an accurate charge pump current, optional. Do not use any capacitor across this resistor to prevent noise coupling via this node. If the internal 12 k Ω is selected (default setting), this pin can be left open. |
| | | | | LVCMOS output for PLL_LOCK information. This pin is set high if the PLL is in lock (see feature description). This output can be programmed to be digital lock detect or analog lock detect (see feature description). |
| PILL LOOK | 4.0 | 0.5 | 1/0 | The PLL is locked (set high), if the rising edge either of PRI_REF or SEC_REF clock and VCXO_IN clock at the phase frequency detector (PFD) are inside the lock detect window for a predetermined number of successive clock cycles. |
| PLL_LOCK | A8 | A8 25 | I/O | The PLL is out-of-lock (set low), if the rising edge of either the PRI_REF or SEC_REF) clock and VCXO_IN clock at the PFD are outside the lock detect window or if a certain frequency offset between reference frequency and feedback frequency (VCXO) is detected. |
| | | | | Both, the lock detect window and the number of successive clock cycles are user definable (via SPI). |
| Y0A:Y0B Y1A:Y1B Y2A:Y2B Y3A:Y3B Y4A:Y4B | F1, G1, H2, H3, H4, H5, H6, H7, G8, F8 | 46, 47, 3, 4, 7, 8, 11,12, 16, 17 | 0 | The outputs of the CDCM7005 are user definable and can be any combination of up to five LVPECL outputs or up to 10 LVCMOS outputs. The outputs are selectable via SPI (Word 1, Bit 2-6). The power-up setting is all outputs are LVPECL. |

Copyright © 2005–2013, Texas Instruments Incorporated



ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)(1)

| | | VALUE / UNIT |
|---|---|-----------------------------------|
| V _{CC} , A _{VCC} , V _{CC_CP} | Supply voltage range (2) | −0.5 V to 4.6 V |
| VI | Input voltage range (3) | –0.5 V to V _{CC} + 0.5 V |
| Vo | Output voltage range (3) | -0.5 V to V _{CC} + 0.5 V |
| l _{out} | Output current for LVPECL/LVCMOS outputs $(0 < V_O < V_{CC})$ | ±50 mA |
| I _{IN} | Input current (V _I < 0, V _I > V _{CC}) | ±20 mA |
| T _{stg} | Storage temperature range | −65°C to 150°C |
| TJ | Maximum junction temperature | 125°C |

⁽¹⁾ Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute—maximum—rated conditions for extended periods may affect device reliability.

(2) All supply voltages have to be supplied at the same time.

Package Thermal Resistance for RGZ (QFN) Package⁽¹⁾ (2)

| Airflow (Ifm) | θ _{JA} (°C/W) | θ _{JC} (°C/W) | θ _{JP} (°C/W) ⁽³⁾ | ψ _{JT} (°C/W) |
|---------------|------------------------|------------------------|---------------------------------------|------------------------|
| 0 | 29.9 | 22.4 | 1.5 | 0.2 |
| 150 | 24.7 | | | 0.2 |
| 250 | 23.2 | | | 0.2 |
| 500 | 21.5 | | | 0.3 |

⁽¹⁾ The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S2P (high-k board).

(2) Connected to GND with nine thermal vias (0,3 mm diameter).

Package Thermal Resistance for ZVA (BGA) Package⁽¹⁾

| Airflow (m/s) | θ _{JA} (°C/W) | θ _{JC} (°C/W) | $\theta_{\rm JB}$ (°C/W) ⁽²⁾ | Ψ _{JT} (°C/W) |
|---------------|------------------------|------------------------|---|------------------------|
| 0 m/s | 53.9 | 28.3 | 38.6 | 0.7 |
| 1 m/s | 49.8 | | | 0.7 |
| 2 m/s | 48.5 | | | 0.8 |

⁽¹⁾ The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S2P (high-k board).

RECOMMENDED OPERATING CONDITIONS

| | | MIN | NOM | MAX | UNIT |
|----------------------|--|---------------------|-----|----------------------|------|
| V_{CC} , AV_{CC} | Supply voltage | 3 | 3.3 | 3.6 | V |
| V _{CC_CP} | Supply voltage | 2.3 | | V_{CC} | V |
| V_{IL} | Low-level input voltage LVCMOS, see (1) | | | $0.3 V_{CC}$ | V |
| V_{IH} | High-level input voltage LVCMOS, see (1) | 0.7 V _{CC} | | | V |
| I _{OH} | High-level output current LVCMOS (includes all status pins) | | | -8 | mA |
| I _{OL} | Low-level output current LVCMOS (includes all status pins) | | | 8 | mA |
| V_{I} | Input voltage range LVCMOS | 0 | | 3.6 | V |
| V _{INPP} | Input amplitude LVPECL (V _{VCXO_IN} – V _{VCXO_IN}) ⁽²⁾ | 0.5 | | 1.3 | V |
| V_{IC} | Common-mode input voltage LVPECL | 1 | | V _{CC} -0.3 | V |
| T _A | Operating free-air temperature | -40 | | 85 | °C |

V_{IL} and V_{IH} are required to maintain ac specifications; the actual device function tolerates a smaller input level of 1V, if an ac-coupling to V_{CC}/2 is provided.

Product Folder Links : CDCM7005

³⁾ The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

⁽³⁾ θ_{JP} (junction pad) is used for the QFN package, because the main heat flow is from the junction to the GND pad of the QFN.

²⁾ θ_{JB} (junction board) is used for the BGA package, because the main heat flow is from junction to the board.

⁽²⁾ V_{INPP} minimum and maximum is required to maintain ac specifications; the actual device function tolerates at a minimum V_{INPP} of 150 mV.



TIMING REQUIREMENTS

over recommended ranges of supply voltage, load and operating free air temperature

| | PARAMETER | MIN | TYP MAX | UNIT |
|---------------------------------|--|-----|---------|----------|
| PRI_REF/SE | C_REF_IN REQUIREMENTS | | | |
| f _{REF_IN} | LVCMOS primary or secondary reference clock frequency ⁽¹⁾ (2) | 0 | 200 | MHz |
| t _r / t _f | Rise and fall time of PRI_REF or SEC_REF signals from 20% to 80% of V _{CC} | | 4 | ns |
| dutyREF | Duty cycle of PRI_REF or SEC_REF at V _{CC} /2 | 40% | 60% | <u> </u> |
| VCXO_IN, V | CXO_IN REQUIREMENTS | | | |
| f _{VCXO_IN} | VCXO clock frequency ⁽³⁾ | 0 | 2200 | MHz |
| t _r / t _f | Rise and fall time 20% to 80% of VINPP at 80 MHz to 800 MHz ⁽⁴⁾ | | 3 | ns |
| dutyVCXO | Duty cycle of VCXO clock | 40% | 60% | |
| SPI/CONTR | OL REQUIREMENTS (see Figure 14) | | | |
| f _{CTRL_CLK} | CTRL_CLK frequency | | 20 | MHz |
| t _{su1} | CTRL_DATA to CTRL_CLK setup time | 10 | | ns |
| t _{h2} | CTRL_DATA to CTRL_CLK hold time | 10 | | ns |
| t ₃ | CTRL_CLK high duration | 25 | | ns |
| t ₄ | CTRL_CLK low duration | 25 | | ns |
| t _{su5} | CTRL_LE to CTRL_CLK setup time | 10 | | ns |
| t _{su6} | CTRL_CLK to CTRL_LE setup time | 10 | | ns |
| t ₇ | CTRL_LE pulse width | 20 | | ns |
| t _r / t _f | Rise and fall time of CTRL_DATA CTRL_CLK, CTRL_LE from 20% to 80% of V _{CC} | | 4 | ns |
| PD, RESET, | HOLD, REF_SEL REQUIREMENTS | • | | |
| t _r / t _f | Rise and fall time of the PD, RESET, HOLD, REF_SEL signal from 20% to 80% of V _{CC} | | 4 | ns |

⁽¹⁾ At Reference Clock less than 2 MHz, the device stays in normal operation mode but the frequency detection circuitry resets the STATUS_REF signal to low. In this case, the status of the STATUS_REF is no longer relevant.

(2) f_{REF_IN} can be up to 250 MHz in typical operating mode (25°C / 3.3-V V_{CC}).

DEVICE CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP MAX | UNIT |
|------------------------|--|---|----------------|-------------------|------|
| OVERALL | | | | | |
| I _{CC_LVPECL} | Supply current (I _{CC} over frequency see | $\begin{array}{l} f_{VCXO} = 245.76 \text{ MHz,} \\ f_{REF \mid IN} = 30.72 \text{ MHz,} \\ PFD = 240 \text{ kHz,} I_{CP} = 2 \text{ mA, all outputs} \\ are LVPECL and Div-by-8 (load, see Figure 13) \end{array}$ | | 210 260 | mA |
| I _{CC_LVCMOS} | Figure 1 through Figure 4) f f F | $ \begin{cases} f_{VCXO} = 245.76 \text{ MHz,} \\ f_{REF\ IN} = 30.72 \text{ MHz,} \\ PFD = 240 \text{ kHz, I}_{CP} = 2 \text{ mA, All outputs} \\ are LVCMOS and Div-by-8 (load, 10 pF) \end{cases} $ | | 120 150 | mA |
| I _{CCPD} | Power-down current | $ \begin{aligned} f_{\text{IN}} &= 0 \text{ MHz, V}_{\text{CC}} = 3.6 \text{ V, AV}_{\text{CC}} = 3.6 \text{ V,} \\ V_{\text{CC_CP}} &= 3.6 \text{ V,} \\ V_{\text{I}} &= 0 \text{ V or V}_{\text{CC}} \end{aligned} $ | | 100 300 | μА |
| | High-impedance state output current | $V_O = 0 \text{ V or } V_{CC} - 0.8 \text{ V}$ | | ±40 | μΑ |
| I _{OZ} | for Yx outputs | V _O = 0 V or V _{CC} | | ±100 | μΑ |
| V _{I_REF_CP} | Voltage on I_REF_CP (external current path for accurate charge pump current) | 12 kΩ to GND at pin D8 (BGA), pin 22 (QFN) | | 1.21 | V |
| V _{BB} | Output reference voltage | $V_{CC} = 3 \text{ V} - 3.6 \text{ V}; I_{BB} = -0.2 \text{ mA}$ | V _C | ₀ –1.3 | V |
| Co | Output capacitance for Yx | $V_{CC} = 3.3 \text{ V}, V_O = 0 \text{ V or } V_{CC}$ | | 2 | pF |
| | Input capacitance at PRI_REF and SEC_REF | $V_I = 0 \text{ V or } V_{CC}, V_I = 0 \text{ V or } V_{CC}$ | 2.7 | 2.7 | |
| Cı | Input capacitance at CTRL_LE, CTRL_CLOCK, CTRL_DATA | V _I = 0 V or V _{CC} | | 2 | pF |

Product Folder Links : CDCM7005

⁽³⁾ If the Feedback Clock (derives from VCXO input) is less than 2 MHz, the device stays in normal operation mode but the frequency detection circuitry resets the STATUS_VCXO signal and PLL_LOCK signal to low. Both status signals are no longer relevant. This effects the HOLD-over function as well, as the PLL_LOCK signal is no longer valid!

⁽⁴⁾ Use a square wave for lower frequencies (< 80 MHz).



DEVICE CHARACTERISTICS (continued)

over recommended operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |
|------------------------------|--|--|-----------------------|-----|-----------------------|------|--|
| LVCMOS | | | | | | | |
| f _{clk} | Output frequency, see ⁽¹⁾ , ⁽²⁾ , Figure 6, and Figure 7 | Load = 5 pF to GND, 1 k Ω to V _{CC} , 1 k Ω to GND | | | 250 | MHz | |
| V_{IK} | LVCMOS input clamp voltage | $V_{CC} = 3 \text{ V}, I_{I} = -18 \text{ mA}$ | | | -1.2 | V | |
| I _I | LVCMOS input current for CTRL_LE, CTRL_CLK, CTRL_DATA | $V_I = 0 \text{ V or } V_{CC}, V_{CC} = 3.6 \text{ V}$ | | | ±5 | μΑ | |
| I _{IH} | LVCMOS input current for PD, RESET, HOLD, REF_SEL, PRI_REF, SEC_REF, (see (3)) | V _I = V _{CC} , V _{CC} = 3.6 V | | | 5 | μΑ | |
| I _{IL} | LVCMOS input current for PD, RESET, HOLD, REF_SEL, PRI_REF, SEC_REF, (see (3)) | V _I = 0 V, V _{CC} = 3.6 V | -15 | | -35 | μΑ | |
| V_{OH} | High-level output voltage for LVCMOS | V_{CC} = min to max, I_{OH} = -100 μ A | V _{CC} -0.1 | | | | |
| | outputs | $V_{CC} = 3 \text{ V}, I_{OH} = -6 \text{ mA}$ | 2.4 | | | V | |
| | | V _{CC} = 3 V, I _{OH} = -12 mA | 2 | | | | |
| V _{OL} | Low-level output voltage for LVCMOS | V_{CC} = min to max, I_{OL} = 100 μ A | | | 0.1 | | |
| | outputs | V _{CC} = 3 V, I _{OL} = 6 mA | | | 0.5 | V | |
| | | V _{CC} = 3 V, I _{OL} = 12 mA | | | 0.8 | | |
| I _{OH} | High-level output current | V _{CC} = 3.3 V, V _O = 1.65 V | | -30 | | mA | |
| I _{OL} | Low-level output current | V _{CC} = 3.3 V, V _O = 1.65 V | | 33 | | mA | |
| tpho | Phase offset (REF_IN to Y output) (4) | VREF_IN = V _{CC} /2, Y = V _{CC} /2, see Figure 11, Load = 10 pF | | 1.8 | | ns | |
| t _{sk(p)} | LVCMOS pulse skew, see Figure 10 | Crosspoint to V _{CC} /2 load, see Figure 12 | | | 150 | ps | |
| $t_{pd(LH)}$ $t_{pd(HL)}$ | Propagation delay from VCXO_IN to Yx, see Figure 10 | Crosspoint to $V_{CC}/2$, Load = 10 pF, see Figure 12 (PLL bypass mode) | 2 | 2.5 | 3 | ns | |
| | LVCMOS single-ended output skew, | All outputs have the same divider ratio | | | 55 | | |
| t _{sk(o)} | see ⁽⁵⁾ and Figure 10 | Outputs have different divider ratios | | | 70 | ps | |
| Duty cycle | LVCMOS | V _{CC} /2 to V _{CC} /2 | 49% | | 51% | | |
| t _{slew-rate} | Output rise/fall slew rate | 20% to 80% of swing (load see Figure 12) | 2.4 | 3.5 | | V/ns | |
| LVPECL | | | | | | | |
| f _{clk} | Output frequency, see (6) and Figure 5 | Load, see Figure 13 | 0 | · | 1500 | MHz | |
| l _l | LVPECL input current | V _I = 0 V or V _{CC} | | | ±20 | μΑ | |
| V _{OH} | LVPECL high-level output voltage | Load, See Figure 13 | V _{CC} -1.18 | | V _{CC} -0.81 | V | |
| V _{OL} | LVPECL low-level output voltage | Load, See Figure 13 | V _{CC} -2 | | V _{CC} -1.55 | V | |
| V _{OD} | Differential output voltage | See Figure 9 and load, see Figure 13 | 500 | | | mV | |
| t _{pho} | Phase offset (REF_IN to Y output) ⁽⁵⁾ | VREF_IN = V _{CC} /2 to cross point of Y, see Figure 11 | -200 | | 100 | ps | |
| t _{pd(LH)} | Propagation delay time, VCXO_IN to | Cross point-to-cross point, load see Figure 13 | 340 | 490 | 640 | ps | |
| t _{pd(HL)} | Yx, see Figure 10 | See Figure 15 | | | | | |

Submit Documentation Feedback

Copyright © 2005–2013, Texas Instruments Incorporated

⁽¹⁾ f_{clk} can be up to 400 MHz in the typical operating mode (25°C / 3.3-V V_{CC}). The total power consumption limit of 700 mW for the BGA package can be violated if several LVCMOS outputs switch at high frequency (see Figure 3 and Figure 4).

⁽²⁾ Operating the LVCMOS or LVPECL output above the maximum frequency will not cause a malfunction to the device, but the output signal swing may no longer meet the output specification.

⁽³⁾ These inputs have an internal 150-k Ω pullup resistor.

⁽⁴⁾ This is valid only for the same frequency of REF_IN clock and Y output clock. It can be adjusted by the SPI controller (reference delay M and VCXO delay N).

⁽⁵⁾ The $t_{sk(0)}$ specification is only valid for equal loading of all outputs.

⁶⁾ Operating the LVCMOS or LVPECL output above the maximum frequency will not cause a malfunction to the device, but the output signal swing may no longer meet the output specification.



DEVICE CHARACTERISTICS (continued)

over recommended operating free-air temperature range (unless otherwise noted)

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------------------|---|--|------|-----------------------|-----|------|
| | LVPECL output skew ⁽⁵⁾ | Load see Figure 13, all outputs have the same divider ratio | | | 20 | 200 |
| t _{sk(o)} | LVFEOL output skew | Load see Figure 13, outputs have different divider ratios | | | 50 | ps |
| t _r / t _f | Rise and fall time | 20% to 80% of V _{OUTPP} , see Figure 9 | 120 | 170 | 220 | ps |
| Cı | Input capacitance at VCXO_IN, VCXO_IN | | | 1.5 | | pF |
| LVCMOS-TO- | LVPECL | | | | | |
| t _{sk(P_C)} | Output skew between LVCMOS and LVPECL outputs, see ⁽⁷⁾ and Figure 10 | Cross point to V _{CC} /2; load, see Figure 12 and Figure 13 | 1.7 | 2 | 2.4 | ns |
| PLL ANALOG | LOCK | | | | | |
| I _{OH} | High-level output current | V _{CC} = 3.6 V, V _O = 1.8 V | | -110 | | μΑ |
| I _{OL} | Low-level output current | V _{CC} = 3.6 V, V _O = 1.8 V | | 110 | | μA |
| I _{OZH LOCK} | High-impedance state output current for PLL LOCK output (8) | V _O = 3.6 V (PD is set low) | | 45 | 65 | μΑ |
| I _{OZL LOCK} | High-impedance state output current for PLL LOCK output (8) | V _O = 0 V (PD is set low) | | | ±5 | μΑ |
| V _{IT+} | Positive input threshold voltage | V _{CC} = min to max | | V _{CC} ×0.55 | | V |
| V _{IT} | Negative input threshold voltage | V _{CC} = min to max | | V _{CC} ×0.35 | | V |
| PHASE DETE | CTOR | | | | • | |
| f _{CPmax} | Maximum charge pump frequency | Default PFD pulse width delay | | | 100 | MHz |
| CHARGE PUI | MP | | | | · | |
| I _{CP} | Charge pump sink/source current range (9) | $V_{CP} = 0.5 V_{CC_CP}$ | ±0.2 | | ±3 | mA |
| I _{CP3St} | Charge pump 3-state current | 0.5 V < V _{CP} < V _{CC_CP} - 0.5 V | | | 10 | nA |
| | | V _{CP} = 0.5 V _{CC_CP} , internal reference resistor, SPI default settings | | 10% | | |
| Ісра | ICP absolute accuracy | V_{CP} = 0.5 V_{CC_CP} , external reference resistor 12 k Ω (1%) at I_REF_CP, SPI default settings | | 5% | | |
| I _{CPM} | Sink/source current matching | 0.5 V < V _{CP} < V _{CC_CP} - 0.5 V, SPI default settings | | 2.5% | | |
| I _{VCPM} | ICP vs VCP matching | 0.5 V < V _{CP} < V _{CC CP} - 0.5 V | | 5% | | |

Product Folder Links: CDCM7005

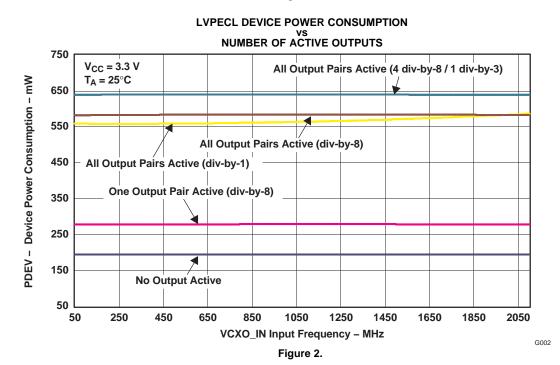
The phase of LVCMOS is lagging in reference to the phase of LVPECL. Lock output has an $80\text{-}k\Omega$ pulldown resistor. Defined by SPI settings.

TEXAS INSTRUMENTS

TYPICAL CHARACTERISTICS

LVPECL SUPPLY CURRENT NUMBER OF ACTIVE OUTPUTS 250 All Output Pairs Active (4 div-by-8 / 1 div-by-3) 230 Δ For div-by-3/6 210 Icc - Supply Current - mA 190 All Output Pairs Active (div-by-8) All Output Pairs Active (div-by-1) 170 Δ for div-by-2/4/8/16 $V_{CC} = 3.3 V$ 150 $T_A = 25^{\circ}C$ 130 One Output Pair Active (div-by-8) 110 90 **No Output Active** △ For 1 Output Pair 70 50 50 250 450 650 850 1050 1250 1450 1650 1850 2050 VCXO_IN Input Frequency - MHz

A. If div-by-2/4/8/16 is activated for one or more outputs, ' Δ for div-by-2/4/8/16' has to be added to I_{CC} of div-by-1. If div-by-3 or div-by-6 is activated, ' Δ for div-by-2/4/8/16' and ' Δ for div-by3/6' has to be added to I_{CC} of div-by-1.

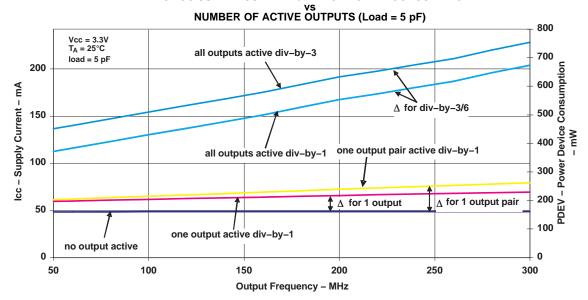


Submit Documentation Feedback

Copyright © 2005–2013, Texas Instruments Incorporated



TYPICAL CHARACTERISTICS (continued) LVCMOS SUPPLY CURRENT / DEVICE POWER CONSUMPTION



B. It is not recommended to exceed power dissipation of 700 mW for the BGA package at T_A 85°C. Figure 3.

LVCMOS SUPPLY CURRENT / DEVICE POWER CONSUMPTION VS NUMBER OF ACTIVE OUTPUTS (Load = 10 pF) 900 $V_{CC} = 3.3 \text{ V}$ $T_A = 25^{\circ}\text{C}$ 250 all outputs active div-by-3 800 Load = 10 pF700 cc - Supply Current - mA 200 Δ for div-by-3/6 150 all outputs active div-by-1 one output pair active div-by-1 300 P 100 ↑∆ for 1 output ∆ for 1 output pair 200 50 100 one output active div-by-1 no output active 0 0 40 80 100 120 140 160 180 200 220 240 260 280 300 Output Frequency - MHz

B. It is not recommended to exceed power dissipation of 700 mW for the BGA package at T_A 85°C. Figure 4.



TYPICAL CHARACTERISTICS (continued) DIFFERENTIAL LYPECL OUTPUT VOLTAGE

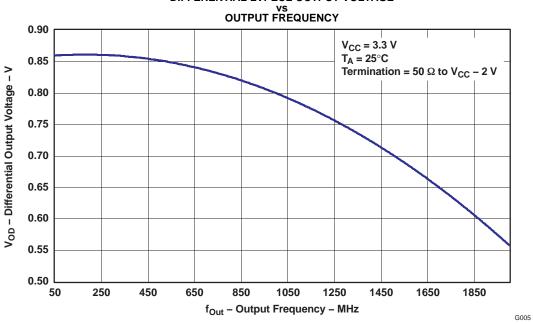
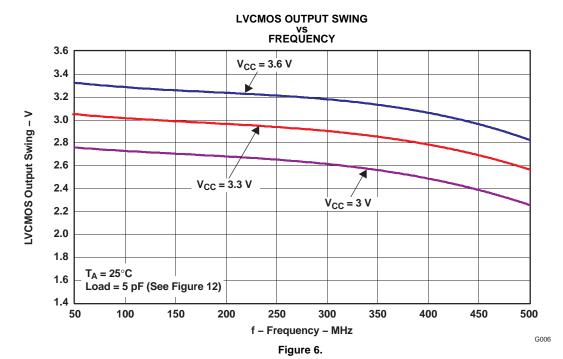


Figure 5.



Submit Documentation Feedback

Copyright © 2005-2013, Texas Instruments Incorporated



TYPICAL CHARACTERISTICS (continued) LVCMOS OUTPUT SWING

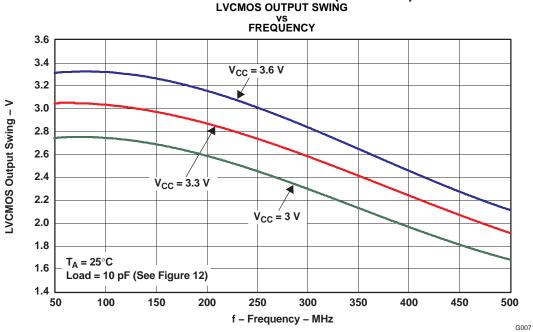
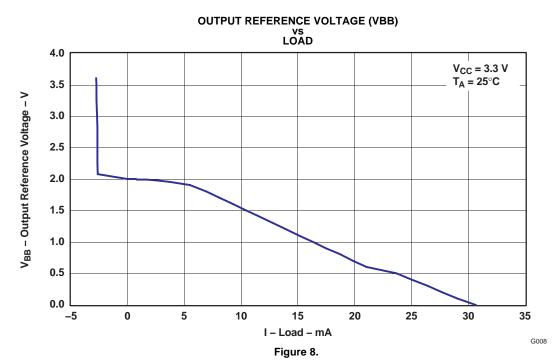


Figure 7.





PARAMETER MEASUREMENT INFORMATION

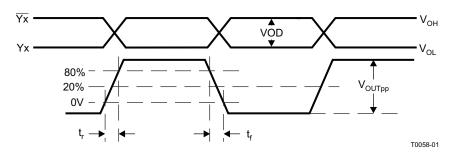
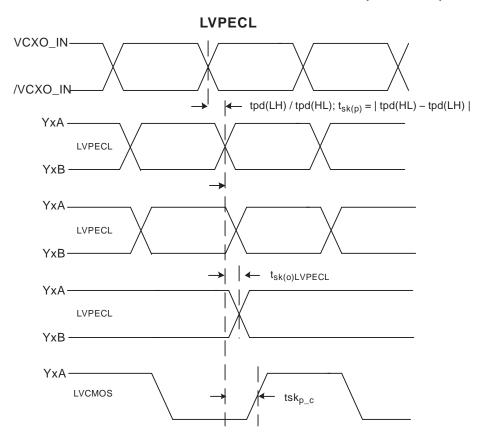
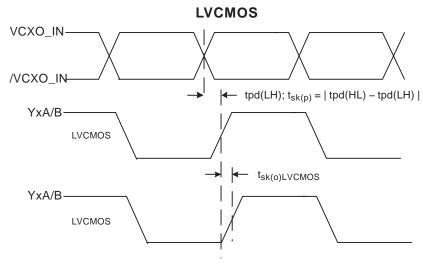


Figure 9. LVPECL Differential Output Voltage and Rise/Fall Time



PARAMETER MEASUREMENT INFORMATION (continued)





- A. Output skew, $t_{sk(o)}$, is calculated as the greater of: The difference between the fastest and the slowest $t_{pd}(LH)n$ (n = 0...4) The difference between the fastest and the slowest $t_{pd}(HL)n$ (n = 0...4)
- B. Pluse skew, $t_{sk(p)}$, is calculated as the magnitude of the absolute time difference between the high-to-low ($t_{pd}(HL)$) and the low-to-high ($t_{pd}(LH)$) propagation delays when a single switching input causes one or more outputs to switch, $t_{sk(p)} = |t_{pd}(HL) t_{pd}(LH)|$. Pulse skew is sometimes referred to as *pulse width distortion or duty cycle skew*.

Figure 10. Output Skew



PARAMETER MEASUREMENT INFORMATION (continued)

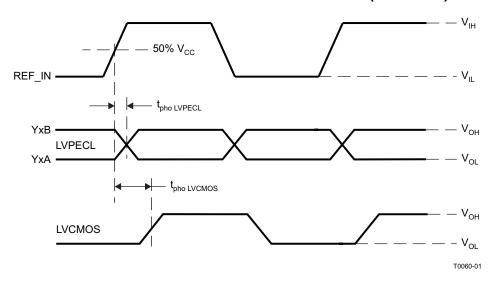


Figure 11. Phase Offset

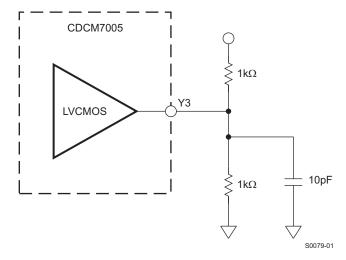


Figure 12. LVCMOS Output Loading During Device Test

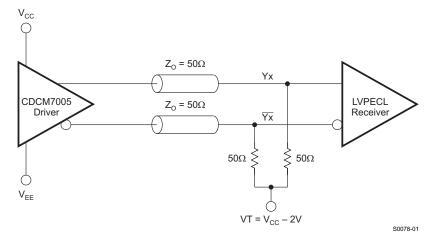


Figure 13. LVPECL Output Loading During Device Test



PARAMETER MEASUREMENT INFORMATION (continued) SPI CONTROL INTERFACE

The serial interface of the CDCM7005 is a simple SPI-compatible interface for writing to the registers of the device and consists of three control lines: CTRL_CLK, CTRL_DATA, and CTRL_LE. There are four 32-bit wide registers, which can be addressed by the two LSBs of a transferred word (bit 0 and bit 1). Every transmitted word must have 32 bits, starting with MSB first. Each word can be written separately. Bit 7, 8, 10, and Bit 12 to 31 of Word 3 are reserved for factory test purposes and must be filled with zeros. The transfer is initiated with the falling edge of CTRL_LE; as long as CTRL_LE is high, no data can be transferred. During CTRL_LE, low data can be written. The data has to be applied at CTRL_DATA and has to be stable before the rising edge of CTRL_CLK. The transmission is finished by a rising edge of CTRL_LE. With the rising edge of CTRL_LE, the new word is asynchronously transferred to the internal register (e.g., N, M, P, ...). Each word has to be separately transmitted by this procedure. Unused or floating inputs must be tied to proper logic level. A $20k\Omega$ or larger pull-up resistor to VCC is recommended.

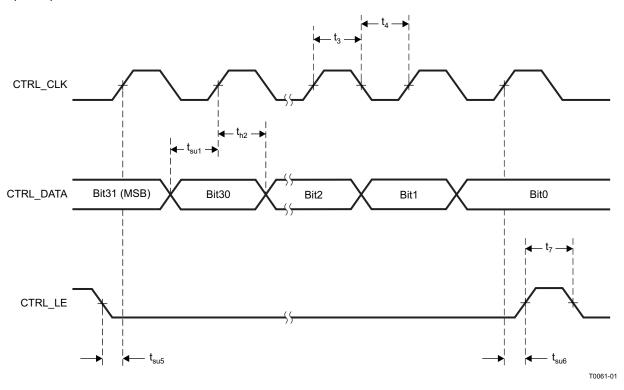


Figure 14. Timing Diagram SPI Control Interface

The SPI serial protocol accepts word Write operation only. There is neither a read, acknowledge, nor a handshake operation.

The following four words include the register settings of the programmable functions of the CDCM7005. It can be modified to the customer application by changing one or more bits. It comes up with a default register setting after power up or if the power down (PD) control signal is applied. The default setting is shown in column five of the following words.

It is recommended to program Word 0, Word 1, Word 2 and Word 3 right after power up and \overline{PD} becomes HIGH. A low active function is shown as [0] and a high active function is shown as [1].



PARAMETER MEASUREMENT INFORMATION (continued)

Word 0

| BIT | BIT NAME | | DESCRIPTION/FUNCTION | POWER UP | PIN AFI | ECTED |
|-----|----------|---------------------------------|--|-----------|---------|--------|
| ыі | DII NAME | | DESCRIPTION/FUNCTION | CONDITION | BGA | QFN |
| 0 | C0 | | Register Selection | 0 | | |
| 1 | C1 | | Register Selection | 0 | | |
| 2 | MO | Reference Divider M | Reference Divider M Bit 0 | 1 | | |
| 3 | M1 | | Reference Divider M Bit 1 | 1 | | |
| 4 | M2 | | Reference Divider M Bit 2 | 1 | | |
| 5 | M3 | | Reference Divider M Bit 3 | 1 | | |
| 6 | M4 | | Reference Divider M Bit 4 | 1 | | |
| 7 | M5 | | Reference Divider M Bit 5 | 1 | | |
| 8 | M6 | | Reference Divider M Bit 6 | 1 | | |
| 9 | M7 | | Reference Divider M Bit 7 | 0 | | |
| 10 | M8 | | Reference Divider M Bit 8 | 0 | | |
| 11 | M9 | | Reference Divider M Bit 9 | 0 | | |
| 12 | N0 | VC(X)O Divider N ⁽¹⁾ | VCXO Divider N Bit 0 | 1 | | |
| 13 | N1 | | VCXO Divider N Bit 1 | 1 | | |
| 14 | N2 | | VCXO Divider N Bit 2 | 1 | | |
| 15 | N3 | | VCXO Divider N Bit 3 | 1 | | |
| 16 | N4 | | VCXO Divider N Bit 4 | 1 | | |
| 17 | N5 | | VCXO Divider N Bit 5 | 1 | | |
| 18 | N6 | | VCXO Divider N Bit 6 | 1 | | |
| 19 | N7 | | VCXO Divider N Bit 7 | 0 | | |
| 20 | N8 | | VCXO Divider N Bit 8 | 0 | | |
| 21 | N9 | | VCXO Divider N Bit 9 | 0 | | |
| 22 | N10 | | VCXO Divider N Bit 10 | 0 | | |
| 23 | N11 | | VCXO Divider N Bit 11 | 0 | | |
| 24 | DLYM0 | Progr. Delay M | Reference Phase Delay M Bit 0 | 0 | | |
| 25 | DLYM1 | | Reference Phase Delay M Bit 1 | 0 | | |
| 26 | DLYM2 | | Reference Phase Delay M Bit 2 | 0 | | |
| 27 | DLYN0 | Progr. Delay N | Feedback Phase Delay N Bit 0 | 0 | | |
| 28 | DLYN1 | | Feedback Phase Delay N Bit 1 | 0 | | |
| 29 | DLYN2 | | Feedback Phase Delay N Bit 2 | 0 | | |
| 30 | MANAUT | Manual or Auto Ref. | Manual Reference Clock Selection [0] Automatic Reference Clock Selection [1] | 0 | A1, B1 | 36, 37 |
| 31 | REFDEC | Freq. Detect | Reference Frequency Detection on [0], off [1] (2) | 0 | C8 | 23 |

⁽¹⁾ The frequency applied to the Divider N must be smaller than 300 MHz. A sufficient P Divider must be selected with the FB_MUX to maintain this criteria.

⁽²⁾ If set to low, STATUS_REF will be in normal operation. If set to high, STATUS_REF will be high, even if no valid clock is detected (<2 MHz). This is useful for reference inputs frequencies less than 2 MHz where the frequency detection circuitry normally resets the STATUS_REF signal to low.



Word 1

| DIT | DIT NAME | | DESCRIPTION/FUNCTION | POWER UP | PIN AFF | ECTED |
|-----|----------|---------------------------------|---|-----------|---------|--------|
| BIT | BIT NAME | | DESCRIPTION/FUNCTION | CONDITION | BGA | QFN |
| 0 | C0 | | Register Selection | 1 | | |
| 1 | C1 | | Register Selection | 0 | | |
| 2 | OUTSEL0 | Output (Yx) Signaling Selection | For Output Y0A, Y0B: LVPECL = enabled [1]; LVCMOS = enabled [0]; | 1 | F1, G1 | 46, 47 |
| 3 | OUTSEL1 | | For Outputs Y1A, Y1B: LVPECL = enabled [1]; LVCMOS = enabled [0]; | 1 | H2, H3 | 3, 4 |
| 4 | OUTSEL2 | | For Outputs Y2A, Y2B: LVPECL = enabled [1]; LVCMOS = enabled [0]; | 1 | H4, H5 | 7, 8 |
| 5 | OUTSEL3 | | For Outputs Y3A, Y3B: LVPECL = enabled [1]; LVCMOS = enabled [0]; | 1 | H6, H7 | 11, 12 |
| 6 | OUTSEL4 | | For Outputs Y4A, Y4B: LVPECL = enabled [1]; LVCMOS = enabled [0]; | 1 | G8, F8 | 16,17 |
| 7 | OUT0A0 | Output Y0 Mode | Output Y0A Mode Bit 0 | 0 | F1 | 46 |
| 8 | OUT0A1 | | Output Y0A Mode Bit 1 | 0 | F1 | 46 |
| 9 | OUT0B0 | | Output Y0B Mode Bit 0 | 0 | G1 | 47 |
| 10 | OUT0B1 | | Output Y0B Mode Bit 1 | 0 | G1 | 47 |
| 11 | OUT1A0 | Output Y1 Mode | Output Y1A Mode Bit 0 | 0 | H2 | 3 |
| 12 | OUT1A1 | | Output Y1A Mode Bit 1 | 0 | H2 | 3 |
| 13 | OUT1B0 | | Output Y1B Mode Bit 0 | 0 | НЗ | 4 |
| 14 | OUT1B1 | + | Output Y1B Mode Bit 1 | 0 | НЗ | 4 |
| 15 | OUT2A0 | Output Y2 Mode | Output Y2A Mode Bit 0 | 0 | H4 | 7 |
| 16 | OUT2A1 | | Output Y2A Mode Bit 1 | 0 | H4 | 7 |
| 17 | OUT2B0 | | Output Y2B Mode Bit 0 | 0 | H5 | 8 |
| 18 | OUT2B1 | | Output Y2B Mode Bit 1 | 0 | H5 | 8 |
| 19 | OUT3A0 | Output Y3 Mode | Output Y3A Mode Bit 0 | 0 | H6 | 11 |
| 20 | OUT3A1 | | Output Y3A Mode Bit 1 | 0 | H6 | 11 |
| 21 | OUT3B0 | | Output Y3B Mode Bit 0 | 0 | H7 | 12 |
| 22 | OUT3B1 | | Output Y3B Mode Bit 1 | 0 | H7 | 12 |
| 23 | OUT4A0 | Output Y4 Mode | Output Y4A Mode Bit 0 | 0 | G8 | 16 |
| 24 | OUT4A1 | | Output Y4A Mode Bit 1 | 0 | G8 | 16 |
| 25 | OUT4B0 | | Output Y4B Mode Bit 0 | 0 | F8 | 17 |
| 26 | OUT4B1 | | Output Y4B Mode Bit 1 | 0 | F8 | 17 |
| 27 | SREF | Status Ref. | Displays the status of the reference clock at the STATUS_REF output [0] | 0 | C8 | 23 |
| | | | Displays the selected clock (high for PRI_REF and low for SEC_REF clock) at the STATUS_REF output [1] | | | |
| 28 | SXOIREF | Status VCXO or | Selects STATUS_VCXO [0] | 0 | D8, A8 | 22, 25 |
| | | I_REF_CP | Selects I_REF_CP [1] which enable external reference resistor used for charge pump current and analog PLL lock detect output current. | | | |
| 29 | ADLOCK | Analog or Digital Lock | Selects Digital PLL_LOCK [0] Selects Analog PLL_LOCK [1] | 0 | A8 | 25 |
| 30 | 90DIV4 | 90 degree shift div- | 90 degree output phase shift in div-4 mode on [1]; off [0] ⁽¹⁾ | 0 | Yx | Yx |
| 31 | 90DIV8 | 90 degree shift div- | 90 degree output phase shift in div-8 mode on [1]; off [0] ⁽¹⁾ | 0 | Yx | Yx |

⁽¹⁾ The P 16-Div has to be selected to obtain the 90 degree phase shift. If bit 30 or bit 31 is set, the Div-by-16 mode is no longer available. The outputs are switched in pairs. Only one bit can be set at a time. If both bits set to [1] at the same time, no 90 degree phase shift mode is selected (equal to off-mode setting).



Word 2

| ыт | BIT | | DESCRIPTION/FUNCTION | POWER UP | PIN AFFECTED | |
|-----|--------|--------------|--|---------------|--------------|--------|
| BIT | NAME | | DESCRIPTION/FUNCTION | CONDITIO N | BGA | QFN |
| 0 | C0 | | Register Selection | 0 | | |
| 1 | C1 | | Register Selection | 1 | | |
| 2 | CP_DIR | CP Direction | Determines in which direction CP current regulates (Reference Clock leads to Feedback Clock – see Figure 23) | 0 | A4 | 31 |
| | | | positive CP output current [0];negative CP output current [1]; | | | |
| 3 | PRECP | | Preset charge pump output voltage to VCC_CP/2, on [1], off [0] | 0 | A4 | 31 |
| 4 | CP0 | CP Current | CP Current Setting Bit 0 | 0 | A4 | 31 |
| 5 | CP1 | | CP Current Setting Bit 1 | 1 | A4 | 31 |
| 6 | CP2 | | CP Current Setting Bit 2 | 0 | A4 | 31 |
| 7 | CP3 | | CP Current Setting Bit 3 | 1 | A4 | 31 |
| 8 | PFD0 | PFD Pulse | PFD Pulse Width PFD Bit 0 | 0 | A4 | 31 |
| 9 | PFD1 | Width | PFD Pulse Width PFD Bit 1 | 0 | A4 | 31 |
| 10 | FBMUX0 | FB_MUX | Feedback MUX Select Bit 0 | 1 | | |
| 11 | FBMUX1 | | Feedback MUX Select Bit 1 | 0 | | |
| 12 | FBMUX2 | _ | Feedback MUX Select Bit 2 | 1 | | |
| 13 | Y0MUX0 | Y0_MUX | Output Y0x Select Bit 0 | 1 | F1, G1 | 46, 47 |
| 14 | Y0MUX1 | | Output Y0x Select Bit 1 | 0 | F1, G1 | 46, 47 |
| 15 | Y0MUX2 | | Output Y0x Select Bit 2 | 1 | F1, G1 | 46, 47 |
| 16 | Y1MUX0 | Y1_MUX | Output Y1x Select Bit 0 | 1 | H2, H3 | 3, 4 |
| 17 | Y1MUX1 | | Output Y1x Select Bit 1 | 0 | H2, H3 | 3, 4 |
| 18 | Y1MUX2 | | Output Y1x Select Bit 2 | 1 | H2, H3 | 3, 4 |
| 19 | Y2MUX0 | Y2_MUX | Output Y2x Select Bit 0 | 1 | H4, H5 | 7, 8 |
| 20 | Y2MUX1 | | Output Y2x Select Bit 1 | 0 | H4, H5 | 7, 8 |
| 21 | Y2MUX2 | | Output Y2x Select Bit 2 | 1 | H4, H5 | 7, 8 |
| 22 | Y3MUX0 | Y3_MUX | Output Y3x Select Bit 0 | 1 | H6, H7 | 11, 12 |
| 23 | Y3MUX1 | | Output Y3x Select Bit 1 | 0 | H6, H7 | 11, 12 |
| 24 | Y3MUX2 | | Output Y3x Select Bit 2 | 1 | H6, H7 | 11, 12 |
| 25 | Y4MUX0 | Y4_MUX | Output Y4x Select Bit 0 | 1 | G8, F8 | 16, 17 |
| 26 | Y4MUX1 | | Output Y4x Select Bit 1 | 0 | G8, F8 | 16, 17 |
| 27 | Y4MUX2 | | Output Y4x Select Bit 2 | 1 | G8, F8 | 16, 17 |
| 28 | PD | | Power Down mode on [0], off [1] | 1 | Yx | Yx |
| 29 | RESHOL | | RESET or HOLD Pin definition: RESET [0] or HOLD [1] | 0 | H8 | 14 |
| 30 | RESET | | Resets all dividers [0] - (equal to RESET pin function) | 1 | | |
| 31 | HOLD | | 3-state charge pump [0] - (equal to HOLD pin function) | 1 | A4 | 31 |



Word 3

| ВІТ | BIT | | DESCRIPTION/FUNCTION | POWER UP | PIN AFFECTED | |
|-----|---------|---------------------------|--|-----------|--------------|-----|
| DII | NAME | | DESCRIPTION/FUNCTION | CONDITION | BGA | QFN |
| 0 | | | Register selection | 1 | | |
| 1 | | | Register selection | 1 | | |
| 2 | LOCKW 0 | Lock Window | Lock-detect window Bit 0 | 1 | A8 | 25 |
| 3 | LOCKW 1 | | Lock-detect window Bit 1 | 0 | A8 | 25 |
| 4 | LOCKC0 | Lock Cycles | Number of coherent lock events Bit 0 | 0 | A8 | 25 |
| 5 | LOCKC1 | | Number of coherent lock events Bit 1 | 1 | A8 | 25 |
| 6 | FOFF | Frequency Offset | Frequency offset mode only for out-of-lock detection on [1] or off [0] ⁽¹⁾ | 0 | A8 | 25 |
| 7 | RES | | RESERVED | 0 | RES | RES |
| 8 | RES | | RESERVED | 0 | RES | RES |
| 9 | HOLDF | HOLD Function | Enables the frequency hold-over function on [1], off [0] | 0 | | |
| 10 | | | RESERVED | 0 | RES | RES |
| 11 | HOLDTR | HOLD Trigger Condition | HOLD function always activated [1]; ⁽²⁾ Triggered by analog PLL lock detect outputs [0] (if analog PLL Lock signal is set then HOLD is activated; if analog PLL lock signal is reset then HOLD is deactivated). | 0 | | |
| 12 | RES | | RESERVED | 0 | RES | RES |
| 13 | RES | | RESERVED | 0 | RES | RES |
| 14 | RES | | RESERVED | 0 | RES | RES |
| 15 | RES | | RESERVED | 0 | RES | RES |
| 16 | GTME | | General Test Mode Enable. Test Mode is only enabled if this bit is set to 1. | 0 | | |
| 17 | RES | | RESERVED | 0 | RES | RES |
| 18 | RES | | RESERVED | 0 | RES | RES |
| 19 | RES | | RESERVED | 0 | RES | RES |
| 20 | RES | | RESERVED | 0 | RES | RES |
| 21 | RES | | RESERVED | 0 | RES | RES |
| 22 | RES | | RESERVED | 0 | RES | RES |
| 23 | RES | | RESERVED | 0 | RES | RES |
| 24 | RES | | RESERVED | 0 | RES | RES |
| 25 | RES | | RESERVED | 0 | RES | RES |
| 26 | RES | | RESERVED | 0 | RES | RES |
| 27 | RES | | RESERVED | 0 | RES | RES |
| 28 | PFDFC | | PFD Frequency Control. Data provided to the PFD are feed through to the corresponding STATUS pins (3) | 0 | D8 | 22 |
| 29 | RES | | RESERVED | 0 | RES | RES |
| 30 | RES | | RESERVED | 0 | RES | RES |
| 31 | RES | | RESERVED | 0 | RES | RES |

⁽¹⁾ If Frequency offset mode only for out-of-lock detection is on, the selected lock detect window is valid for lock detect. Independent from this, out of lock is valid if a frequency offset is detected.
HOLD function always activated is recommended for test purposes only.

⁽³⁾ The maximum frequency for the STATUS_VCXO pin is 100 MHz.



FUNCTIONAL DESCRIPTION OF THE LOGIC

Reference Divider M (Word 0)⁽⁴⁾

| М9 | M8 | M7 | M6 | M5 | M4 | М3 | M2 | M1 | МО | Div by | Default |
|----|----|----|----|----|----|----|----|----|----|--------|---------|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 2 | |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 3 | |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 4 | |
| | | | | | • | | | | | | |
| 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 128 | Yes |
| | | | | | • | | | | | | |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 0 | 1 | 1022 | |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 0 | 1023 | |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1024 | |

⁽⁴⁾ If the divider value is Q, then the code will be the binary value of (Q-1).

VC(X)O Feedback Divider N (Word 0)⁽¹⁾ (2)

| N11 | N10 | N0 | N8 | N7 | N6 | N5 | N4 | N3 | N2 | N1 | N0 | Div by | Default |
|-----|-----|----|----|----|----|----|----|----|----|----|----|--------|---------|
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 2 | |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 3 | |
| 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 4 | |
| | | | | | | • | | | | | | | |
| | | | | | | • | | | | | | | |
| 0 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 128 | Yes |
| | | | | | | • | | | | | | | |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 0 | 1 | 4094 | |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 0 | 4095 | |
| 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 4096 | |

 ⁽¹⁾ If the divider value is Q, then the code will be the binary value of (Q-1).
 (2) The frequency applied to the Divider N must be smaller than 300 MHz. A sufficient P Divider must be selected with the FB_MUX to maintain this criteria.



Output Mode Selection for LVCMOS and LVPECL Outputs: Y0A, Y0B, Y1A ... Y4B (Word 1)⁽¹⁾

| | OUTSELx | OUTxB1 | OUTxB0 | LVCMOS [YxB] | OUTxA1 | OUTxA0 | LVCMOS [YxA] | Default |
|--------|---------|--------|--------|-----------------|--------|--------|-----------------|---------|
| LVCMOS | 0 | 0 | 0 | Active | 0 | 0 | Active | |
| | 0 | 0 | 1 | 3-state | 0 | 1 | 3-state | |
| | 0 | 1 | 0 | Inverting | 1 | 0 | Inverting | |
| | 0 | 1 | 1 | Low | 1 | 1 | Low | |
| | OUTSELx | OUTxB1 | OUTxB0 | | OUTxA1 | OUTxA0 | LVCMOS [YxA] | Default |
| LVPECL | 1 | х | х | | х | 0 | Active | Yx |
| | 1 | х | х | | х | 1 | 3-state | |

⁽¹⁾ If the differential LVPECL output e.g. Y0A:Y0B is selected (bit 2 of word 1), then only bit 7 of word 1 defines the output mode for Y0A:Y0B. The settings of bit 8, bit 9, and bit 10 of word 1 are therefore not relevant to the Y0A:Y0B. This applies for the other LVPECL outputs as well.

Reference Delay M (PRI_REF or SEC_REF) and Feedback Delay N (VCXO) Phase Adjustment (Word 0)⁽¹⁾

| DLYM2 / DLYN2 | DLYM1 / DLYN1 | DLYM0 / DLYN0 | Phase Offset | Default |
|---------------|---------------|---------------|--------------|---------|
| 0 | 0 | 0 | 0 ps | Yes |
| 0 | 0 | 1 | ±160 ps | |
| 0 | 1 | 0 | ±320 ps | |
| 0 | 1 | 1 | ±480 ps | |
| 1 | 0 | 0 | ±830 ps | |
| 1 | 0 | 1 | ±1130 ps | |
| 1 | 1 | 0 | ±1450 ps | |
| 1 | 1 | 1 | ±1750 ps | |

⁽¹⁾ If Progr. Delay M is set, all Yx outputs are lagging to the reference clock according to the value set. If Progr. If Delay N is set; all Yx outputs are leading to the reference clock according to the value set. Above are typical values at V_{CC} = 3.3 V, Temp = 25°C, PECL-output relate to Div4 mode.

PFD Pulse Width Delay (Word 2)

| PFD1 ⁽¹⁾ | PFD0 ⁽¹⁾ | PFD Pulse Width ⁽¹⁾ (2) | Default ⁽¹⁾ |
|---------------------|---------------------|------------------------------------|------------------------|
| 0 | 0 | 1.5 ns | Yes |
| 0 | 1 | 3 ns | |
| 1 | 0 | 4.5 ns | |
| 1 | 1 | 6 ns | |

⁽¹⁾ The PFD pulse width delay gets around the dead zone of the PFD transfer function and reduces phase noise and reference spurs.

Lock-Detect Window (Word 3)

| LOCKW1 | LOCKW0 | Phase-Offset at PFD Input ⁽¹⁾ | Default |
|--------|--------|--|---------|
| 0 | 0 | 3.5 ns | |
| 0 | 1 | 8.5 ns | Yes |
| 1 | 0 | 18.5 ns | |
| 1 | 1 | Frequency offset (2) | |

⁽¹⁾ Typical Values at $V_{CC} = 3.3 \text{ V}$, Temp = 25°C.

⁽²⁾ Typical values at $V = 3.3 V_{CC}$, Temp = 25°C.

⁽²⁾ The PLL is out-of-lock (PLL_LOCK set low) if a certain frequency offset between reference frequency and feedback frequency (VCXO) at PFD input is detected. The minimum detectable frequency offset depends on the device setting and can be calculated:

⁽a) $f_{offsetPDF} = f_{PFD} - 1/(1/f_{PFD} + PWD)$

⁽b) f_{offsetPFD} = detectable frequency offset at PFD between the reference frequency (f_{REF}) and feedback frequency (f_{FB})

⁽c) f_{PFD} = frequency at phase-frequency detection circuitry

⁽d) PWD = PFD Pulse Width Delay



Number of Successive Lock Events Inside the Lock Detect Window (Word 3)

| LOCKC1 ⁽¹⁾ | LOCKC0 ⁽¹⁾ | No. of Successive Lock Events ⁽¹⁾ | Default ⁽¹⁾ |
|-----------------------|-----------------------|--|------------------------|
| 0 | 0 | 1 | |
| 0 | 1 | 16 | |
| 1 | 0 | 64 | Yes |
| 1 | 1 | 256 | |

⁽¹⁾ This does not apply to Out-of-Lock condition.

Charge Pump Current (Word 2)

| CP3 | CP2 | CP1 | CP0 | Typical Charge Pump Current | Default |
|-----|-----|-----|-----|-----------------------------|---------|
| 0 | 0 | 0 | 0 | 0 μA (3-state) | |
| 0 | 0 | 0 | 1 | 200 μΑ | |
| 0 | 0 | 1 | 0 | 400 μA | |
| 0 | 0 | 1 | 1 | 600 µA | |
| 0 | 1 | 0 | 0 | Αμ 008 | |
| 0 | 1 | 0 | 1 | 1 mA | |
| 0 | 1 | 1 | 0 | 1.2 mA | |
| 0 | 1 | 1 | 1 | 1.4 mA | |
| 1 | 0 | 0 | 0 | 1.6 mA | |
| 1 | 0 | 0 | 1 | 1.8 mA | |
| 1 | 0 | 1 | 0 | 2.0 mA | Yes |
| 1 | 0 | 1 | 1 | 2.2 mA | |
| 1 | 1 | 0 | 0 | 2.4 mA | |
| 1 | 1 | 0 | 1 | 2.6 mA | |
| 1 | 1 | 1 | 0 | 2.8 mA | |
| 1 | 1 | 1 | 1 | 3 mA | |

FB_MUX Selection (Word 2)

| FBMUX2 | FBMUX1 | FBMUX0 | Selected VC(X)O Signal for the Phase Discriminator | Default |
|--------|--------|--------|---|---------|
| 0 | 0 | 0 | Div by 1 | |
| 0 | 0 | 1 | Div by 2 | |
| 0 | 1 | 0 | Div by 3 | |
| 0 | 1 | 1 | Div by 4 | |
| 1 | 0 | 0 | Div by 6 | |
| 1 | 0 | 1 | Div by 8 | Yes |
| 1 | 1 | 0 | Div by 16 ⁽¹⁾ | |
| 1 | 1 | 1 | Div by 8 | |

⁽¹⁾ This divider setting depends on the selected P-divider mode for the "Div-by-16" divider. In the default mode (after power up), Div-by-16 is selected. But if bit 30 or bit 31 of word 1 is set to [1], then the Div-by-4 and 90 degree phase shift or Div-by-8 and 90 degree phase shift is selected.

Yx_MUX - Output Divider Selection for Y0, Y1, Y2, Y3, Y4 (Word 2)

| YxMUX2 | YxMUX1 | YxMUX0 | Selected Divided V(C)XO Signal for the Yx Outputs | Default |
|--------|--------|--------|---|---------|
| 0 | 0 | 0 | Div by 1 | |
| 0 | 0 | 1 | Div by 2 | |
| 0 | 1 | 0 | Div by 3 | |

Product Folder Links: CDCM7005

www.ti.com

| YxMUX2 | YxMUX1 | YxMUX0 | Selected Divided V(C)XO Signal for the Yx Outputs | Default |
|--------|--------|--------|---|---------|
| 0 | 1 | 1 | Div by 4 | |
| 1 | 0 | 0 | Div by 6 | |
| 1 | 0 | 1 | Div by 8 | all Yx |
| 1 | 1 | 0 | Div by 16 ⁽¹⁾ | |
| 1 | 1 | 1 | Div by 8 | |

⁽¹⁾ This divider setting depends on the selected P-divider mode for the "Div-by-16" divider. In the default mode (after power up), Div-by-16 is selected. But if bit 30 or bit 31 of word 1 is set to [1], then the Div-by-4 and 90 degree phase shift or Div-by-8 and 90 degree phase shift is selected.

FEATURE DESCRIPTION

Automatic/Manual Reference Clock Switching

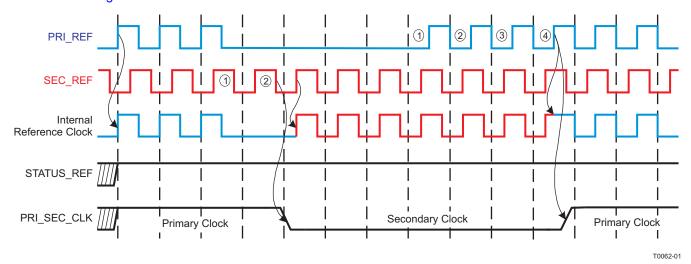
The CDCM7005 supports two reference clock inputs, the primary clock input, PRI_REF, and the secondary clock input, SEC_REF. The clocks can be selected manually or automatically. The respective mode is selected by the dedicated SPI register bit (Word 0, Bit 30).

In the manual mode, the external REF_SEL signal selects one of the two input clocks:

REF_SEL [1] -> primary clock is selected

REF_SEL [0] -> secondary clock is selected

In the automatic mode, the primary clock is selected by default even if both clocks are available. In case the primary clock is not available or fails, then the input switches to the secondary clock as long until the primary clock is back. Figure 15 shows the automatic clock selection.



NOTE: PRI_REF is the preferred clock input.

Figure 15. Behavior of STATUS REF and PRI SEC CLK

In the automatic mode, the frequencies of both clock signals have to be similar, but may differ by up to 20%. The phase of the clock signal can be any.

The clock input circuitry is design to suppress glitches during switching between the primary and secondary clock in the manual and automatic mode. This avoids an undefined switching of the following circuitries.

The phase of the output clock slowly follows the new input phase. There will be no phase-jump at the output. How quick the phase adjustment is done depends on the selected loop parameter, i.e., at a loop bandwidth of <100 Hz; the phase adjustment can take several ms. There is no phase build-out function supported (like in SONET/SDH applications).

Copyright © 2005–2013, Texas Instruments Incorporated



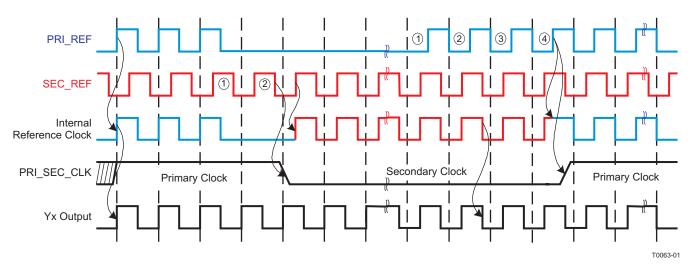


Figure 16. Phase Approach of Output to New Reference Clock

PLL Lock for Analog and Digital Detect

The CDCM7005 supports two PLL lock indications: the digital lock signal or the analog lock signal. Both signals indicate logic high-level at PLL_LOCK if the PLL locks according the selected lock condition.

PLL Lock/Out-of-Lock Definition

The PLL is locked (set high), if the rising edge of the Reference Clock (PRI_REF or SEC_REF clock) and Feedback Clock (VCXO_IN clock) at the PFD (phase frequency detect) are inside a predefined lock detect window, or if no frequency offset appears, for a pre-defined number of successive clock cycles.

The PLL is out-of-lock (set low), if the rising edge of the Reference Clock (PRI_REF or SEC_REF clock) and Feedback Clock (VCXO_IN clock) at the PFD are outside the predefined lock detect window or if a frequency offset appears.

Both, the lock detect window and the number of successive clock cycles are user definable (Word 3, Bit 2-6).

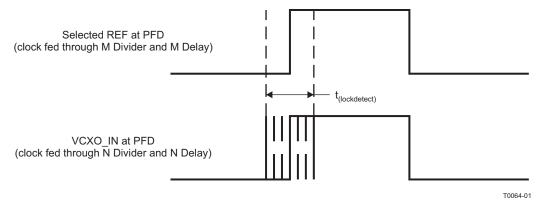


Figure 17. Lock Detect Window

The lock detect window describes the maximum allowed time difference for lock detect between the rising edge of PRI_REF or SEC_REF and VCXO_IN. The time difference is detected at the phase frequency detector. The rising edge of PRI_REF or SEC_REF is taken as reference. The rising edge of VCXO_IN is outside the lock detect window if there is a phase displacement of more than $+0.5 \times t_{(lockdetect)}$ or $-0.5 \times t_{(lockdetect)}$.



Digital vs Analog Lock

Figure 18 and Figure 19 show the circuit for the digital and analog lock. The analog lock operates with an external load capacitor.

When selecting the digital PLL lock option, PLL_LOCK will possibly jitter several times between lock and out of lock until a stable lock is detected. A single low-to-high step can be reached with a wide lock detect window and high number of successive clock cycles. PLL_LOCK returns to out of lock if just one cycle is outside the lock detect window or a frequency offset occurs.

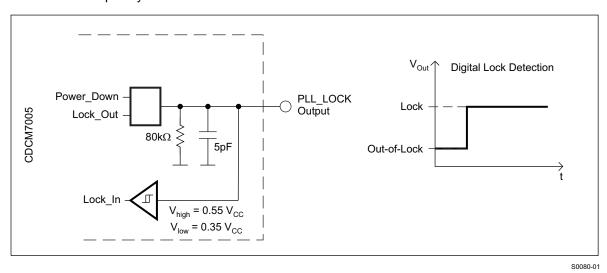


Figure 18. Digital Lock-Detect

When selecting the analog PLL Lock option, the high-pulses load the external capacitor via the internal 110- μ A current source until logic high-level is reached. Therefore, more time is needed to detect logic high level, but jittering of PLL_LOCK will be suppressed in case of digital lock. The time PLL_LOCK needs to return to out of lock depends on the level of V_{Out} , when the current source starts to unload the external capacitor.

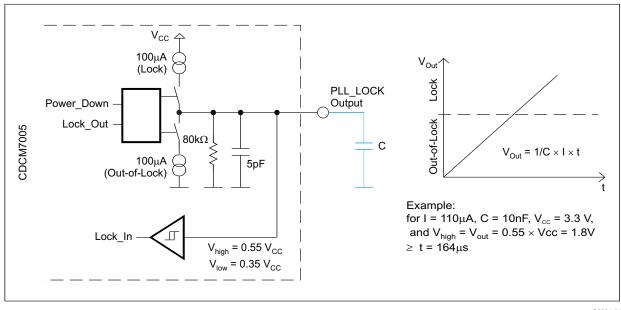


Figure 19. Analog Lock-Detect

S0081-01



Differential LVPECL Outputs and Single-Ended LVCMOS Outputs

The CDCM7005 supports up to 5 × LVPECL outputs or 10 × LVCMOS/LVTTL outputs or any combination of these. The single-ended LVCMOS outputs are arranged in pairs which mean both outputs of a LVCMOS pair have the same frequency but can separately be disabled or inverted. The power up output arrangement is five LVPECL (default setting).

The LVPECL outputs are designed to terminate in to a $50-\Omega$ load to $V_{CC}-2$ V. The LVCMOS outputs supports the standard LVCMOS load (see Figure 12). The LVPECL and LVCMOS outputs can be enabled (normal operation) or disabled (3-state).

In addition, the output phase can be shifted by 90 degrees when using the additional div-by-4 or div-by-8 mode of the P16-Div (see Figure 20). In the default mode (after power up), the div-by-16 mode of the P16-Div is active. To change it to a 90 degree phase shift, bit 30 or bit 31 of word 1 has to be programmed accordingly. The P 16-Div has to be selected via the dedicated YxMUX to obtain the 90 degree phase shift. The outputs are switched in pairs. When selecting the 90 degree phase shift mode, the div-by-16 functions will no longer be available. The 90 degree phase shifted signal is lagging to the non-shifted signal.

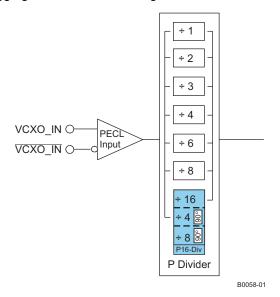


Figure 20. 90 Degree Phase Shift Option of P-Divider

The following diagram shows the LVCMOS and LVPECL output signal when 90 degree phase shift is on.

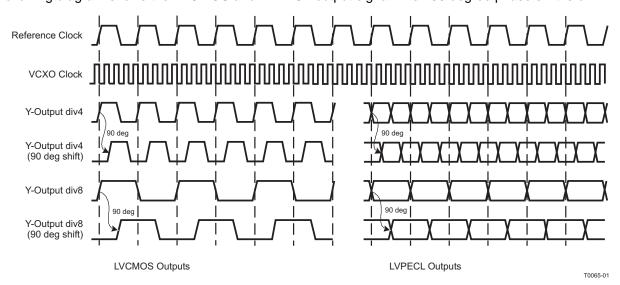


Figure 21. Output Switching Diagram

Copyright © 2005–2013, Texas Instruments Incorporated



In addition, the LVCMOS supports disabled-to-low and 180 degree output phase shift for each output individually. When selecting the 180 degree phase shift together with the 90 degree phase shift, the respective outputs has a total phase shift of 270 degree (see Table 2).

| Table 2. LVC | MOS Phase | Shift O | ptions |
|--------------|-----------|---------|--------|
|--------------|-----------|---------|--------|

| Phase | P-Divider | 180°Phase-Shift | P16-Div - Function | | | |
|-------|---------------|-----------------|----------------------|--|--|--|
| 0° | Any P-Divider | No | div-by-16 | | | |
| 90° | P16-Div | No | div-by-4 or div-by-8 | | | |
| 180° | Any P-Divider | Yes | div-by-16 | | | |
| 270° | P16-Div | Yes | div-by-4 or div-by-8 | | | |

If the P16-Div is selected by the FB_MUX and div-by-4 or div-by-8 is active, the 90 degree phase shifted clock will be synchronized to PRI_REF or SEC_REF. This means all outputs Yxx, which are switched to div-by-4 or div-by-8, are in phase to PRI_REF or SEC_REF. All other outputs are 90 degree phase shifted with leading phase.

Frequency Hold-Over Mode

The HOLD function is a useful feature which helps the designer to improve the system reliability. The HOLD function holds the output frequency in case the input reference clock fails or is disrupted. During HOLD, the charge pump is switched off (3-state) freezing the last valid output frequency. The hold function will be released after a valid reference clock is back. For proper HOLD function, the analog PLL lock detect mode has to be active.

The following register settings are involved with the HOLD function:

- Lock Detect Window (Word 3, Bit 2, 3, 6): Defines the window in ns inside the lock is valid. The size is 3.5 ns, 8.5 ns, 18.5 ns, or a certain frequency offset. Lock is set if reference clock and the feedback clock are inside this predefined lock-detect window for a pre-selected number of successive cycles or if no frequency offset appears.
- Out-of-Lock: Defines the out-of-lock condition: If the reference clock and the feedback clock at the PFD are outside the predefined Lock Detect Window or if a certain frequency offset occurs.
- Cycle-Slip (Word 3, Bit 6): A Frequency offset occurs if a certain frequency offset between reference frequency and feedback frequency (VCXO) at PFD input is detected. The minimum detectable frequency offset depends on the device setting and can be calculated:

 $f_{\text{offsetPDF}} = f_{\text{PFD}} - 1/(1/f_{\text{PFD}} + \text{PWD})$

where

- f_{offsetPFD} = detectable frequency offset at PFD between the reference frequency (f_{REF}) and feedback frequency (f_{rep})
- f_{PFD} = frequency at phase-frequency detection circuitry
- PWD = PFD Pulse Width Delay

(1)

- Number of Clock Cycles (Word 3, Bit 4, 5): Defines the number of successive PFD cycles which have to
 occur inside the lock window to set Lock detect. This applies not for out-of-lock condition.
- Hold-Function (Word 3, Bit 9): Selects HOLD function (see more details below).
- Hold-Trigger (Word 3, Bit 11): Defines whether the HOLD function is always activated (Bit 11 = [1]) or whether it is dependent on the state of the analog PLL lock detect output (Bit 11 = [0]). In the latter case, HOLD is activated, if lock is set (high) and de-activated if Lock is reset (low).
- Analog PLL Lock Detect (Word 1, Bit 29): Analog lock output charges or discharges an external capacitor with every valid lock cycle. The time constant for Lock detect can be set by the value of the capacitor.

The CDCM7005 supports two types of HOLD functions, one external controllable $\overline{\text{HOLD}}$ mode and one internal mode, HOLD.

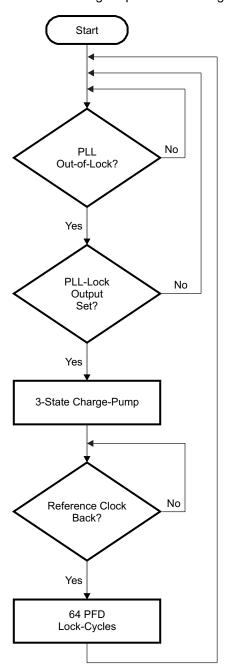
With the *external* HOLD function the charge pump can directly be switched into 3-state (pin H8 [BGA] or pin 14 [QFN] can be programmed for HOLD [Word 2, Bit 29]). This function is also available via SPI register (Word 2, Bit 31).

Copyright © 2005–2013, Texas Instruments Incorporated



If logic low is applied to the $\overline{\text{HOLD}}$ pin, the charge pump will be switched to 3-state. After the $\overline{\text{HOLD}}$ pin is released, the charge pump is switched back in to normal operation with the next valid reference clock cycle at PRI_REF or SEC_REF and the next valid feedback clock cycle at the PFD. During $\overline{\text{HOLD}}$, the P divider and all outputs Yx are at normal operation.

HOLD-Over-Function: The PLL has to be in lock to start the HOLD function. It switches the charge pump in to 3-State when an out-of-lock event occurs. It leaves the 3-state charge pump state when the reference clock is back. Then it starts a locking sequence of 64 cycles before it goes back to the beginning of the HOLD-over loop. The dedicated looking sequence and a digital phase alignment enable a fast lock.



Frequency Hold-Over Function works in combination with the Analog Lock-Detect function only!

PLL is out-of-lock if the phase difference of Reference Clock and Feedback Clock at PFD are outside the predefined Lock-Detect-Window or if a frequency offset occurs.

PLL has to be in LOCK to start HOLD-Function.

(The Analog Lock output is not reset by the first Out-of-Lock event. It stays 'High' depending on the analog time delay (output C-load). The time delay must be long enough to assure proper HOLD function)

(The 'PLL-Lock Output Set?' enquiry can be bypassed by setting the HOLDTR bit to [1] (Word 3, Bit 11)

Charge-Pump is switched into 3-State. P-divider and Yx output are at normal operation.

The Charge-Pump remains in 3-State until the Reference Clock is back. The 1st valid Reference Clock at the PFD releases the Charge-Pump.

The PLL acquire 64 lock cycles to phase align to the input clock.

F0004-01

Figure 22. Frequency HOLD-Over Function



Charge Pump Preset to VCC_CP/2

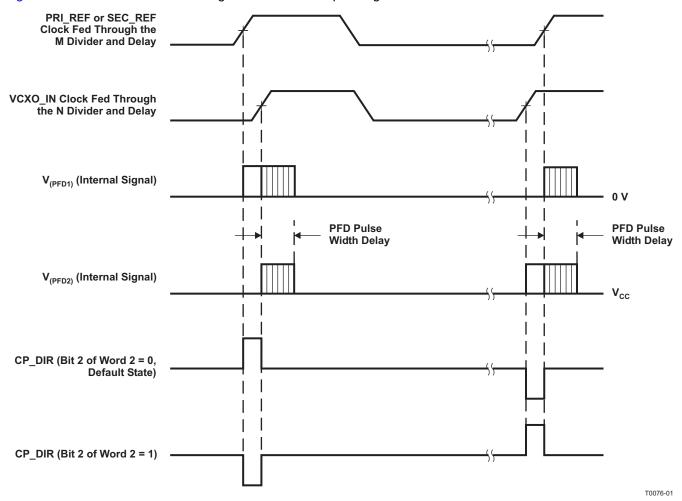
The preset charge pump to VCC_CP/2 is a useful feature to quickly set the center frequency of the VC(X)O after powerup or reset. The adequate control voltage for the VC(X)O will be provided to the charge-pump output by an internal voltage divider of 1 k Ω /1 k Ω to VCC_CP and GND (VCC_CP/2).

This feature helps to get the initial frequency accuracy, i.e. required at CPRI (Common Public Radio Interface) or OBSAI (Open Base Station Architecture Initiative).

The preset charge pump to VCC_CP/2 can be set and reset by SPI register (word 2, bit 3). This feature must be disabled for PLL locking.

Charge Pump Current Direction

The direction of the charge pump (CP) current pulse can be changed by the SPI register (word 2, bit 2). It determines in which direction the CP current regulates (reference clock leads to feedback clock). Most applications use the positive CP output current (power-up condition) because of the use of a passive loop filter. The negative CP current is useful when using an active loop filter concept with inverting operational amplifier. Figure 23 shows the internal PFD signal and the corresponding CP current.



NOTE: The purpose of the PFD pluse width delay is to improve spurious suppression.

Figure 23. Charge Pump Current Direction (VCXO and VCO Support)



APPLICATION INFORMATION

Phase Noise Reference Circuit

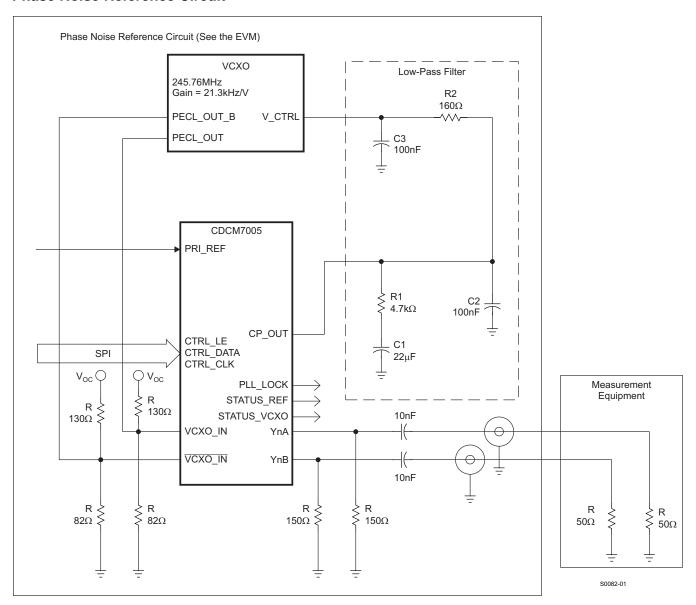


Figure 24. Typical Applications Diagram With Passive Loop Filter



Phase Noise Performance

| (4) | | | REF_IN PHASE NOISE | VCXO PHASE NOISE | Yx PHAS | | |
|----------|---------------------------------------|--|-----------------------|---------------------|--------------------|--------------------|--------|
| | PARAMETER ⁽¹⁾ | TEST CONDITIONS | AT 30.72 MHz | AT 245.76 MHz | LVCMOS | LVPECL | UNIT |
| | | | | | TYP ⁽²⁾ | TYP ⁽²⁾ | |
| phn10 | Phase noise at 10 Hz | | -109 | -75 | -104 | -100 | dBc/Hz |
| phn100 | Phase noise at 100 Hz | | -125 | -97 | -116 | -116 | dBc/Hz |
| phn1k | Phase noise at 1 kHz | Y = 30.72 MHz; f _{PFD} = 200 kHz, Loop BW = 20 Hz, | -134 | -117 | -140 | -140 | dBc/Hz |
| phn10k | Phase noise at 10 kHz | Feedback Divider = 8 x 128 | -136 | -138 | -153 | -152 | dBc/Hz |
| phn100k | Phase noise at 100 kHz | $(N \times P)$, $f_{REF_IN} = 30.72 \text{ MHz}$, M -Divider = 128, $I_{CP} = 2 \text{ mA}$ | -138 | -148 | -156 | -153 | dBc/Hz |
| phn1Mk | Phase noise at 1 MHz | W DIVIDE = 120, 16p = 2 mix | -144 | -148 | -156 | -153 | dBc/Hz |
| phn10M | Phase noise at 10 MHz | | -144 | -148 | -156 | -153 | dBc/Hz |
| PLL Stab | ilization Time | | | | | | |
| tstabi | PLL stabilization time ⁽³⁾ | $\label{eq:main_section} \begin{array}{l} Y = 30.72 \text{ MHz, } f_{PFD} = 200 \\ \text{kHz, Loop BW} = 20 \text{ Hz,} \\ \text{Feedback Divider} = 8 \text{ x } 128 \\ (\text{N x P), } f_{\text{REF_IN}} = 30.72 \text{ MHz,} \\ \text{M-Divider} = 128, I_{\text{CP}} = 2 \text{ mA} \end{array}$ | | | 40 | 00 | ms |

⁽¹⁾ Output phase noise is dependent on the noise of the REF_IN clock and VCXO clock noise floor. The phase noise performance of the BGA and the QFN package is equal. The phase noise measurements were taken with the CDCM7005 EVM and CDCM7005 SPI default settings.

(3) For further explanations, as well as phase noise/jitter test results using various VCXOs, see application note SCAA067.

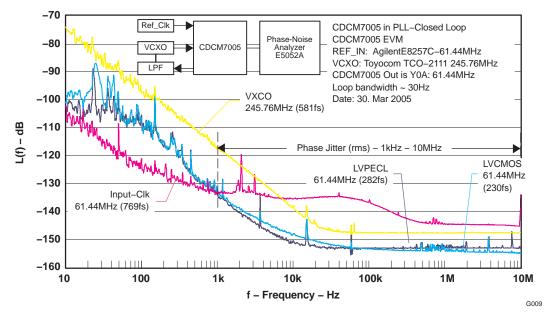


Figure 25. Phase Noise (61.44-MHz REF_IN and 61.44-MHz Output Frequency)

⁽²⁾ The typical stabilization time is based on the above application example. The stabilization criterion was a stable high level of PLL_LOCK.



In-Band Noise Performance

Table 3.

| | PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------------|--|--|-----|------|-----|--------|
| pn _{in-band} | In-band phase noise test conditions | | | -95 | | dBc/Hz |
| pn _{f400} | Phase noise floor at 400 kHz f _{PFD} , in-band noise – 20log(feedback div) ⁽¹⁾ | Y = 900 MHz, f _{PFD} = 400 kHz, Loop BW = 27 kHz, Feedback Divider = 8 x 282 (N x P), f _{RFF IN} = 10 MHz; M-Divider = 25, I _{CP} = | | -162 | | dBc/Hz |
| pn _{f1} | Phase noise floor at 1 Hz f _{PFD} , in-band noise – 20log(feedback div) – 10log(f _{PFD}) ⁽²⁾ | 3 mA | | -218 | | dBc/Hz |

- (1) The synthesizer phase noise floor can be estimated by measuring the in-band noise at the output of the CDCM7005 and subtracting 20log(Feedback Divider) N (in case of CDCM7005 it is the N+P divider). The calculated phase noise floor still based on the PFD update frequency, in the above specification, is 400 kHz.
- (2) The in-band noise can also be normalized to a comparison frequency of 1 Hz. The resulting phase noise floor is: pnfloor = PNmeasured 20log(N+P) 10log(f_{PFD}) where:

pnNfloor = normalized phase noise floor in dBc/Hz

PNmeasured = in-band phase noise measurement in dBc/Hz

20log(N+P) = divider ratio of feedback loop

 $10\log(f_{PFD}) = PFD$ update frequency in Hz

APPLICATION INFORMATION ON THE CLOCK GENERATION FOR INTERPOLATING DACS WITH THE CDCM7005

The CDCM7005, with its specified phase noise performance, is an ideal sampling clock generator for high speed ADCs and DACs. The CDCM7005 is especially of interest for the new high speed DACs, which have integrated interpolation filter. Such DACs achieve sampling rates up to 500 MSPS. This high data rate can typically not be supported from the digital side driving the DAC (e.g., DUC, digital up-converter). Therefore, one approach to interface the DUC to the DAC is the integration of an interpolation filter within the DAC to reduce the data rate at the digital input of the DAC. In 3G systems, for example, a common sampling rate of a high speed DAC is 491.52 MSPS. With a four times interpolation of the digital data, the required input data rate results into 122.88 MSPS, which can be supported easily from the digital side. The DUC GC5016, which supports up to four WCDMA carriers, provides a maximum output data rate of 150 MSPS. An example is shown in Figure 26, where the CDCM7005 supplies the clock signal for the DUC/DDC and ADC/DAC.

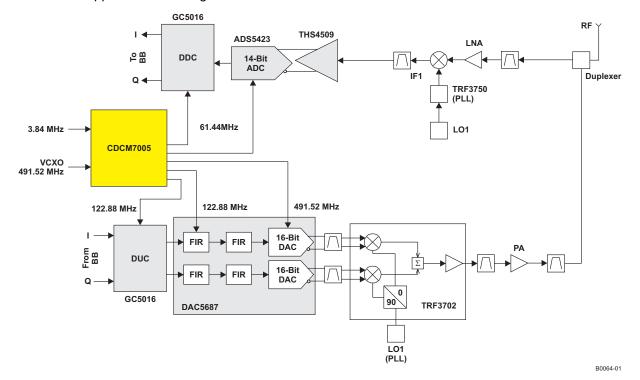


Figure 26. CDCM7005 as a Clock Generator for High Speed ADCs and DACs

Submit Documentation Feedback

Copyright © 2005–2013, Texas Instruments Incorporated



The generation of the two required clock signals (data input clock, clock for DAC) for such an interpolating DAC can be done in different ways. The recommended way is to use the CDCM7005, which generates the fast sampling clock for the DAC from the data input clock signal. The DAC5687 demands that the edges of the two input clocks must be phase aligned within ±500 ps for latching the data properly. This phase alignment is well achieved with the CDCM7005, which assures a maximum skew of 70 ps of the different different outputs to each other.

AC-Coupled Interface to ADC/DAC

Another advantage of this clock solution is that the ADC or DAC can be driven directly in an ac-coupling interface as shown in Figure 27, with an external termination in a differential configuration. There is no need for a transformer to generate a differential signal from a single-ended clock source.

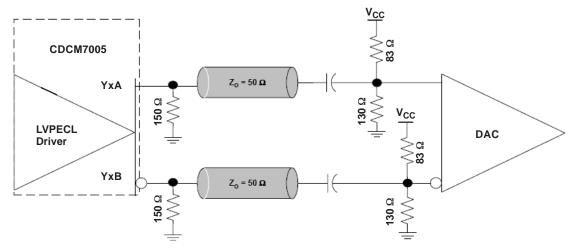


Figure 27. Driving DAC or ADC With PECL Output of the CDCM7005

REVISION HISTORY

| Page |
|------|
| 1 |
| Page |
| 1 |
| Page |
| 22 |
| 22 |
| 22 |
| 22 |
| |



| CI | langes from Revision C (December 2007) to Revision D | Page |
|----|--|------|
| • | Changed VCC pin text From: 3.3-V supply. There is no internal connection between V_{CC} and AV_{CC} . It is recommended that AV_{CC} use its own supply filter. To: 3.3-V supply. V_{CC} and AV_{CC} should always have the same supply voltage. It is recommended that AV_{CC} use its own supply filter. | 4 |
| • | Added text to the CTRL_LE pin - Unused or floating inputs must be tied to proper logic level. A 20kΩ or larger pull-up resistor to VCC is recommended. | 4 |
| • | Added text to the CTRL_CLK pin - Unused or floating inputs must be tied to proper logic level. A 20kΩ or larger pull-up resistor to VCC is recommended. | 4 |
| • | Added text to the CTRL_DATA pin - Unused or floating inputs must be tied to proper logic level. A 20kΩ or larger pull-up resistor to VCC is recommended. | 4 |
| • | Added text to the \overline{PD} pin - It is recommended to ramp up the \overline{PD} with the same time as V_{CC} and AV_{CC} or later. The ramp up rate of the \overline{PD} should not be faster than the ramp up rate of V_{CC} and AV_{CC} . | |
| • | Added text to the SPI CONTROL INTERFACE section - Unused or floating inputs must be tied to proper logic level A 20kΩ or larger pull-up resistor to VCC is recommended. | |
| • | Added text to the SPI CONTROL INTERFACE section - It is recommended to program Word 0, Word 1, Word 2 and Word 3 right after power up and PD becomes HIGH. | 17 |
| • | Changed From: RES To: GTME | 2′ |
| • | Changed From: RES To: PFDFC | 2′ |
| Cł | nanges from Revision D (August 2009) to Revision E | Page |
| • | Changed PLL_LOCK pin description, replaced cycle-slip text. | 5 |
| • | Changed Note 1 of table Word 3 | 2′ |
| • | Changed table Word 3, Cycle Slip (Bit 6) To: Frequency Offset | 2′ |
| • | Changed table Lock-Detect Window (Word 3) - Clip slip To: Frequency offset, and Note 2 | 23 |
| • | Changed the Frequency Hold-Over Mode section | 29 |
| • | Changed text From: Cycle-Slip To: Frequency Offset in Figure 22 | 30 |





11-Apr-2013

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | _ | Pins | _ | | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Top-Side Markings | Samples |
|------------------|--------|--------------|---------|------|------|----------------------------|------------------|---------------------|--------------|-------------------|---------|
| | (1) | | Drawing | | Qty | (2) | | (3) | | (4) | |
| CDCM7005RGZR | ACTIVE | VQFN | RGZ | 48 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-3-260C-168 HR | -40 to 85 | CDCM7005 | Samples |
| CDCM7005RGZRG4 | ACTIVE | VQFN | RGZ | 48 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-3-260C-168 HR | -40 to 85 | CDCM7005 | Samples |
| CDCM7005RGZT | ACTIVE | VQFN | RGZ | 48 | 250 | Green (RoHS & no Sb/Br) | Call TI | Level-3-260C-168 HR | -40 to 85 | CDCM7005 | Samples |
| CDCM7005RGZTG4 | ACTIVE | VQFN | RGZ | 48 | 250 | Green (RoHS & no Sb/Br) | Call TI | Level-3-260C-168 HR | -40 to 85 | CDCM7005 | Samples |
| CDCM7005ZVA | ACTIVE | BGA | ZVA | 64 | 348 | Pb-Free (RoHS) | SNAGCU | Level-3-260C-168 HR | -40 to 85 | CDCM7005 | Samples |
| CDCM7005ZVAR | ACTIVE | BGA | ZVA | 64 | 1000 | Pb-Free (RoHS) | SNAGCU | Level-3-260C-168 HR | -40 to 85 | CDCM7005 | Samples |
| CDCM7005ZVAT | ACTIVE | BGA | ZVA | 64 | 250 | Pb-Free (RoHS) | SNAGCU | Level-3-260C-168 HR | -40 to 85 | CDCM7005 | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.



PACKAGE OPTION ADDENDUM

11-Apr-2013

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CDCM7005:

• Space: CDCM7005-SP

NOTE: Qualified Version Definitions:

• Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION





| | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

| All differsions are normal | | | | | | | | | | | | |
|----------------------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
| CDCM7005RGZR | VQFN | RGZ | 48 | 2500 | 330.0 | 16.4 | 7.3 | 7.3 | 1.5 | 12.0 | 16.0 | Q2 |
| CDCM7005RGZT | VQFN | RGZ | 48 | 250 | 330.0 | 16.4 | 7.3 | 7.3 | 1.5 | 12.0 | 16.0 | Q2 |
| CDCM7005ZVAR | BGA | ZVA | 64 | 1000 | 330.0 | 16.4 | 8.3 | 8.3 | 2.25 | 12.0 | 16.0 | Q1 |
| CDCM7005ZVAT | BGA | ZVA | 64 | 250 | 330.0 | 16.4 | 8.3 | 8.3 | 2.25 | 12.0 | 16.0 | Q1 |

www.ti.com 8-Feb-2013

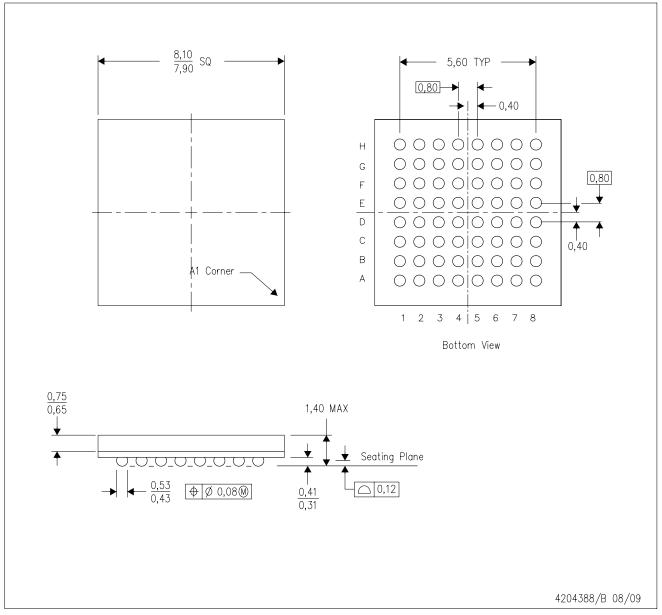


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| CDCM7005RGZR | VQFN | RGZ | 48 | 2500 | 336.6 | 336.6 | 28.6 |
| CDCM7005RGZT | VQFN | RGZ | 48 | 250 | 336.6 | 336.6 | 28.6 |
| CDCM7005ZVAR | BGA | ZVA | 64 | 1000 | 336.6 | 336.6 | 28.6 |
| CDCM7005ZVAT | BGA | ZVA | 64 | 250 | 336.6 | 336.6 | 28.6 |

ZVA (S-PBGA-N64)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. This is a Pb-free package.





- NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Quad Flatpack, No-leads (QFN) package configuration.
 - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - F. Falls within JEDEC MO-220.



RGZ (S-PVQFN-N48)

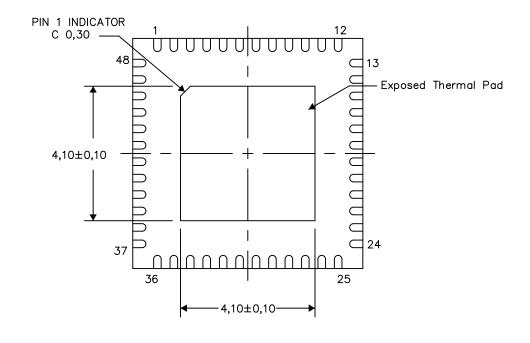
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

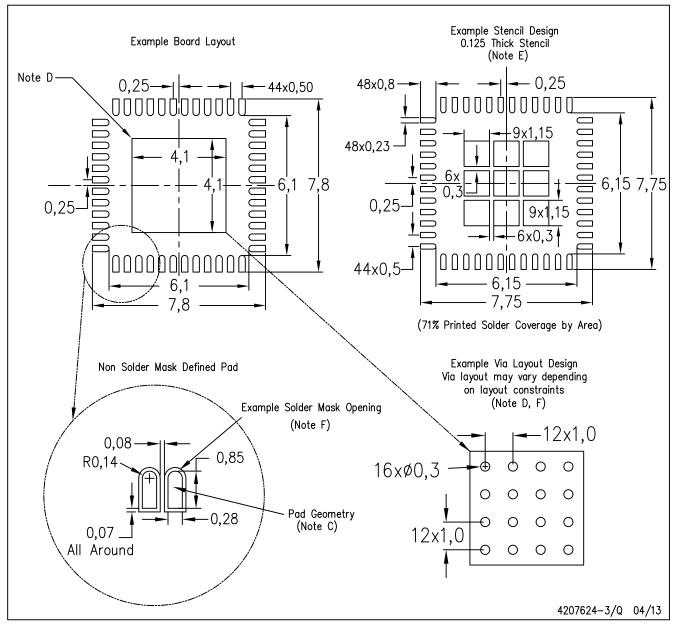
4206354-3/U 04/13

NOTE: All linear dimensions are in millimeters



RGZ (S-PVQFN-N48)

PLASTIC QUAD FLATPACK NO-LEAD



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products Applications

Audio www.ti.com/audio Automotive and Transportation www.ti.com/automotive Communications and Telecom **Amplifiers** amplifier.ti.com www.ti.com/communications **Data Converters** dataconverter.ti.com Computers and Peripherals www.ti.com/computers **DLP® Products** www.dlp.com Consumer Electronics www.ti.com/consumer-apps

DSP **Energy and Lighting** dsp.ti.com www.ti.com/energy Clocks and Timers www.ti.com/clocks Industrial www.ti.com/industrial Interface interface.ti.com Medical www.ti.com/medical logic.ti.com Logic Security www.ti.com/security

Power Mgmt power.ti.com Space, Avionics and Defense www.ti.com/space-avionics-defense

Microcontrollers <u>microcontroller.ti.com</u> Video and Imaging <u>www.ti.com/video</u>

RFID www.ti-rfid.com

OMAP Applications Processors www.ti.com/omap TI E2E Community e2e.ti.com/omap

Wireless Connectivity <u>www.ti.com/wirelessconnectivity</u>